SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd.

588 West Jindu Road, Xinqiao, Songjiang, 201612 Shanghai, China
Telephone: +86 (0) 21 6191 5666
Fax: +86 (0) 21 6191 5678
ee.shanghai@sgs.com

TEST REPORT

Application No.:	SHEM1706004210IT
Applicant:	Zhejiang Dahua Vision Technology Co., Ltd.
Address of Applicant:	No.1199, Bin'an Road, Binjiang District, Hangzhou, P.R. China
Manufacturer:	Zhejiang Dahua Vision Technology Co., Ltd.
Address of Manufacturer:	No.1199, Bin'an Road, Binjiang District, Hangzhou, P.R. China
Factory:	Zhejiang Dahua Vision Technology Co., Ltd.
Address of Factory:	No.1199, Bin'an Road, Binjiang District, Hangzhou, P.R. China
Equipment Under Test (EUT):	
EUT Name:	IP CAMERA
Model No.:	Refer to page 2
¤	Please refer to section 2 of this report which indicates which model was actually tested and which were electrically identical.
Standards:	EN 55032:2015
	EN 61000-3-2:2014
	EN 61000-3-3:2013
	EN 55024:2010+A1:2015
	EN 50130-4:2011+A1:2014
Date of Receipt:	2017-06-30
Date of Test:	2017-06-30 to 2017-07-07
Date of Issue:	2017-07-17
Test Result :	**Pass***

* In the configuration tested, the EUT complied with the standards specified above.

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EU Declaration of Conformity and compliance with all relevant EU Directives.

Parlam Zhan
E&E Section Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

Model No.:

DH-IPC-HFW2531TP-VFS-27135, DH-IPC-HFW2531TN-VFS-27135, DH-IPC-HFW2531TP-ZS-27135, DH-IPC-HFW2531TN-ZS-27135, H-IPC-HFW2531TP-VFAS-27135, DH-IPC-HFW2531TN-VFAS-27135, DH-IPC-HFW2531TP-ZAS-27135, DH-IPC-HFW2531TN-ZAS-27135, IPC-HFW2531TP-VFS-27135, IPC-HFW2531TN-VFS-27135, IPC-HFW2531TP-ZS-27135, IPC-HFW2531TN-ZS-27135,IPC-HFW2531TP-VFAS-27135, IPC-HFW2531TN-VFAS-27135, IPC-HFW2531TP-ZAS-27135, IPC-HFW2531TN-ZAS-27135, DH-IPC-HFW2531TP-VFS, DH-IPC-HFW2531TN-VFS, DH-IPC-HFW2531TP-ZS, DH-IPC-HFW2531TN-ZS, DH-IPC-HFW2531TP-VFAS, DH-IPC-HFW2531TN-VFAS, DH-IPC-HFW2531TP-ZAS, DH-IPC-HFW2531TN-ZAS, IPC-HFW2531TP-VFS, IPC-HFW2531TN-VFS, IPC-HFW2531TP-ZS, IPC-HFW2531TN-ZS, IPC-HFW2531TP-VFAS, IPC-HFW2531TN-VFAS, IPC-HFW2531TP-ZAS, IPC-HFW2531TN-ZAS, DH-IPC-HFW2431TP-VFS-27135, DH-IPC-HFW2431TN-VFS-27135, DH-IPC-HFW2431TP-ZS-27135, DH-IPC-HFW2431TN-ZS-27135, DH-IPC-HFW2431TP-VFAS-27135, DH-IPC-HFW2431TN-VFAS-27135, DH-IPC-HFW2431TP-ZAS-27135, DH-IPC-HFW2431TN-ZAS-27135, IPC-HFW2431TP-VFS-27135, IPC-HFW2431TN-VFS-27135, IPC-HFW2431TP-ZS-27135, IPC-HFW2431TN-ZS-27135, IPC-HFW2431TP-VFAS-27135, IPC-HFW2431TN-VFAS-27135, IPC-HFW2431TP-ZAS-27135, IPC-HFW2431TN-ZAS-27135, DH-IPC-HFW2431TP-VFS, DH-IPC-HFW2431TN-VFS, DH-IPC-HFW2431TP-ZS, DH-IPC-HFW2431TN-ZS, DH-IPC-HFW2431TP-VFAS, DH-IPC-HFW2431TN-VFAS, DH-IPC-HFW2431TP-ZAS, DH-IPC-HFW2431TN-ZAS, IPC-HFW2431TP-VFS, IPC-HFW2431TN-VFS, IPC-HFW2431TP-ZS, IPC-HFW2431TN-ZS, IPC-HFW2431TP-VFAS, IPC-HFW2431TN-VFAS, IPC-HFW2431TP-ZAS, IPC-HFW2431TN-ZAS, DH-IPC-HFW2231TP-VFS-27135, DH-IPC-HFW2231TN-VFS-27135, DH-IPC-HFW2231TP-ZS-27135, DH-IPC-HFW2231TN-ZS-27135, DH-IPC-HFW2231TP-VFAS-27135, DH-IPC-HFW2231TN-VFAS-27135, DH-IPC-HFW2231TP-ZAS-27135, DH-IPC-HFW2231TN-ZAS-27135, IPC-HFW2231TP-VFS-27135, IPC-HFW2231TN-VFS-27135, IPC-HFW2231TP-ZS-27135, IPC-HFW2231TN-ZS-27135, IPC-HFW2231TP-VFAS-27135, IPC-HFW2231TN-VFAS-27135, IPC-HFW2231TP-ZAS-27135, IPC-HFW2231TN-ZAS-27135, DH-IPC-HFW2231TP-VFS, DH-IPC-HFW2231TN-VFS, DH-IPC-HFW2231TP-ZS, DH-IPC-HFW2231TN-ZS, DH-IPC-HFW2231TP-VFAS, DH-IPC-HFW2231TN-VFAS, DH-IPC-HFW2231TP-ZAS, DH-IPC-HFW2231TN-ZAS, IPC-HFW2231TP-VFS, IPC-HFW2231TN-VFS, IPC-HFW2231TP-ZS, IPC-HFW2231TN-ZS, IPC-HFW2231TP-VFAS, IPC-HFW2231TN-VFAS, IPC-HFW2231TP-ZAS, IPC-HFW2231TN-ZAS, DH-IPC-HFW2230TP-VFS-27135, DH-IPC-HFW2230TN-VFS-27135, DH-IPC-HFW2230TP-ZS-27135, DH-IPC-HFW2230TN-ZS-27135, DH-IPC-HFW2230TP-VFAS-27135, DH-IPC-HFW2230TN-VFAS-27135,

DH-IPC-HFW2230TP-ZAS-27135, DH-IPC-HFW2230TN-ZAS-27135, IPC-HFW2230TP-VFS-27135, IPC-HFW2230TN-VFS-27135, IPC-HFW2230TP-ZS-27135, IPC-HFW2230TN-ZS-27135, IPC-HFW2230TP-VFAS-27135, IPC-HFW2230TN-VFAS-27135, IPC-HFW2230TP-ZAS-27135, IPC-

HFW2230TN-ZAS-27135, DH-IPC-HFW2230TP-VFS, DH-IPC-HFW2230TN-VFS, DH-IPC-HFW2230TP-ZS, DH-IPC-HFW2230TN-ZS, DH-IPC-HFW2230TP-VFAS, DH-IPC-HFW2230TN-VFAS, DH-IPC-HFW2230TP-ZAS, DH-IPC-HFW2230TN-ZAS, IPC-HFW2230TP-VFS, IPC-HFW2230TN-VFS, IPC-HFW2230TP-ZS, IPC-HFW2230TN-ZS, IPC-HFW2230TP-VFAS, IPC-HFW2230TN-VFAS, IPC-HFW2230TP-ZAS, IPC-HFW2230TN-ZAS

Revision Record				
Version	**Chapter**	**Date**	**Modifier**	**Remark**
00	/	2017-07-12	/	Original

Authorized for issue by:				
Tested By		Bruce . Tang **Bruce_tang /Project Engineer**		2017-07-12 **Date**
Checked By		Zenger Zhang **Zenger_Zhang /Reviewer**		2017-07-12 **Date**

2 Test Summary

Emission Part				
Item	**Standard**	**Method**	**Requirement**	**Result**
Conducted Emissions at Mains Terminals (150kHz-30MHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Asymmetric Mode Conducted Emissions (150kHz-30MHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Radiated Emissions (30MHz-1GHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Radiated Emissions (above 1GHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Harmonic Current Emission	EN 61000-3-2:2014	EN 61000-3-2:2014	Class A	N/A*
Voltage Fluctuations and Flicker	EN 61000-3-3:2013	EN 61000-3-3:2013	Clause 5 of EN 61000-3-3	Pass
N/A*:Please refer to Section 6.5 for details				

Immunity Part				
Item	**Standard**	**Method**	**Requirement**	**Result**
Electrostatic Discharge	EN 55024:2010 +A1:2015	EN 61000-4-2:2009	4kV Contact Discharge 8kV Air Discharge	Pass
Electrostatic Discharge	EN 50130-4:2011 +A1:2014	EN 61000-4-2:2009	6kV Contact Discharge 2,4,8kV Air Discharge	Pass
Radiated Immunity (80MHz-1GHz)	EN 55024:2010 +A1:2015	EN 61000-4-3:2006 +A1:2008+A2:2010	3V/m, 80%, 1kHz Amp. Mod.	Pass
Electrical Fast Transients/Burst at Power Port	EN 55024:2010 +A1:2015	EN 61000-4-4:2012	1kV 5/50ns Tr/Td 5kHz Repetition Frequency	Pass
Electrical Fast Transients/Burst at Power Port	EN 50130-4:2011 +A1:2014	EN 61000-4-4:2012	2kV 5/50ns Tr/Td 100kHz Repetition Frequency	Pass
Electrical Fast Transients/Burst at Signal Port	EN 55024:2010 +A1:2015	EN 61000-4-4:2012	0.5kV 5/50ns Tr/Td 5kHz Repetition Frequency	Pass
Electrical Fast Transients/Burst at Signal Port	EN 50130-4:2011 +A1:2014	EN 61000-4-4:2012	1kV 5/50ns Tr/Td 100kHz Repetition Frequency	Pass
Surge at Power Port	EN 55024:2010 +A1:2015	EN 61000-4-5:2014	1.2/50μs Tr/Td 1kV Line to Line 2kV Line to Ground	Pass
Surge at Power Port	EN 50130-4:2011 +A1:2014	EN 61000-4-5:2014	1.2/50μs Tr/Td 0.5,1kV Line to Line 0.5,1,2kV Line to Ground	Pass
Surge at Signal Port	EN 55024:2010 +A1:2015	EN 61000-4-5:2014	1.2/50μs Tr/Td 1kV Line to Ground	Pass
Surge at Signal Port	EN 50130-4:2011 +A1:2014	EN 61000-4-5:2014	1.2/50μs Tr/Td 0.5,1kV Line to Ground	Pass
Conducted Immunity at Power Port (150kHz-80MHz)	EN 55024:2010 +A1:2015	EN 61000-4-6:2014	3Vrms (emf),80%,1kHz Amp. Mod.	Pass
Conducted Immunity at Signal Port (150kHz-80MHz)	EN 55024:2010 +A1:2015	EN 61000-4-6:2014	3Vrms (emf),80%,1kHz Amp. Mod.	Pass
Voltage Dips and Interruptions	EN 55024:2010 +A1:2015	EN 61000-4-11:2004	0 % UT for 0.5per 0 % UT for 250per 70 % UT for 25per UT is Supply Voltage	Pass

Immunity Part				
Item	**Standard**	**Method**	**Requirement**	**Result**
Voltage Dips and Interruptions	EN 50130-4:2011 +A1:2014	EN 61000-4-11:2004	80 % UT for 250per 70 % UT for 25per 40 % UT for 10per 0 % UT for 250per UT is Supply Voltage	Pass
Mains Supply Voltage Variations-Conditioning	EN 50130-4:2011 +A1:2014	EN 50130-4:2011+A1:2014	Unom+10% Unom-15%	Pass
Radiated Immunity(80MHz-2.7GHz)	EN 50130-4:2011 +A1:2014	EN 61000-4-3:2006 +A1:2008+A2:2010	10V/m, 80%, 1kHz sinusoidal Amp. Mod.	Pass
Conducted Immunity at Power Port (150kHz-100MHz)	EN 50130-4:2011 +A1:2014	EN 61000-4-6:2014	10Vrms (emf),80%,1kHz sinusoidal Amp. Mod.	Pass
Conducted Immunity at Signal Port (150kHz-100MHz)	EN 50130-4:2011 +A1:2014	EN 61000-4-6:2014	10Vrms (emf),80%,1kHz sinusoidal Amp. Mod.	Pass

InternalSource	UpperFrequency
Below 108MHz	1GHz
108MHz to 500MHz	2GHz
500MHz to 1GHz	5GHz
Above 1GHz	5 times the highest frequency or 6 GHz, whichever is less

Declaration of EUT Family Grouping:

There are series models mentioned in this report and they are the similar in electrical and electronic characters. Only the model DH-IPC-HFW2531TP-ZAS was tested since their differences are sales area and pixel.

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4 General Information

4.1 Details of E.U.T.

Power supply: 12VDC/1.5A or POE
Cable: signal cable : about 0.4m
Internal source: 720MHz

4.2 Description of Support Units

Description	Manufacturer	Model No.
Laptop 1	LENOVO	R400

4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Conducted Emission at mains port using AMN	3.2dB (9kHz to 150kHz)
		3.0dB (150kHz to 30MHz)
	Conducted Emission at mains port using VP	1.9 dB(9kHz to 30MHz)
	Conducted Emission at telecommunication port using AAN	2.4 dB(150kHz to 30MHz)
2	Radiated Power	3.5dB
3	Radiated emission	4.4dB (30MHz-1GHz)
		4.6dB (1GHz-6GHz)
4	Radiated Immunity	1.64dB
5	Conducted Immunity	0.96dB
6	ESD	6 %
7	EFT (Electrical Fast Transients)	5 %
8	Surge Immunity	5 %
9	Voltage Dips and Interruptions	4 %
10	20 system	1.5dB
11	Temperature test	1℃
12	Humidity test	3%
13	DC power test	0.5 %

4.4 Standards Applicable for Testing

Table 1 : Tests Carried Out Under EN 55032:2015

Item	Status
Conducted Emissions at Mains Terminals (150kHz-30MHz)	√
Conducted Differential Voltage Emissions (30MHz-1GHz)	×
Conducted Differential Voltage Emissions (30MHz-2.15GHz)	×
Asymmetric Mode Conducted Emissions (150kHz-30MHz)	√
Radiated Emissions (30MHz-1GHz)	√
Radiated Emissions (above 1GHz)	√
Conducted Emissions at DC Terminals (150kHz-30MHz)	×

Table 2 : Tests Carried Out Under EN 61000-3-2:2014

Item	Status
Harmonic Current Emission	×

Table 3 : Tests Carried Out Under EN 61000-3-3:2013

Item	Status
Voltage Fluctuations and Flicker	√

Table 4 : Tests Carried Out Under EN 55024:2010 +A1:2015

Item	Status
Electrostatic Discharge	√
Radiated Immunity (80MHz-1GHz)	√
Electrical Fast Transients/Burst at Power Port	√
Electrical Fast Transients/Burst at Signal Port	√
Surge at Power Port	√
Surge at Signal Port	√
Conducted Immunity at Power Port (150kHz-80MHz)	√
Conducted Immunity at Signal Port (150kHz-80MHz)	√
Power Frequency Magnetic Field	×
Voltage Dips and Interruptions	√

Table 5 : Tests Carried Out Under EN 50130-4:2011 +A1:2014

Item	Status
Electrostatic Discharge	√
Electrical Fast Transients/Burst at Power Port	√
Electrical Fast Transients/Burst at Signal Port	√
Surge at Power Port	√
Surge at Signal Port	√
Voltage Dips and Interruptions	√
Mains Supply Voltage Variations-Conditioning	√
Radiated Immunity(80MHz-2.7GHz)	√
Conducted Immunity at Power Port (150kHz-100MHz)	√
Electrical Fast Transients/Burst at DC port	×
Surge at DC Port	×
Conducted Immunity at Signal Port (150kHz-100MHz)	√
Conducted Immunity at DC Port (150kHz-100MHz)	×

× Indicates that the test is not applicable
√ Indicates that the test is applicable

4.5 Test Location

All tests were performed at:
SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. E&E Lab
588 West Jindu Road, Xinqiao, Songjiang, 201612 Shanghai, China

Tel: +86 21 6191 5666 Fax: +86 21 6191 5678
No tests were sub-contracted.

4.6 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L0599)**

CNAS has accredited SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **Industry Canada (IC) – IC Assigned Code: 8617A**

The 3m Semi-anechoic chamber of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 8617A-1.

- **VCCI (Member No.: 3061)**

The 3m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-3868,C-4336,T-2221,G-830 respectively.

4.7 Deviation from Standards

None

4.8 Abnormalities from Standard Conditions

None

4.9 Monitoring of EUT for All Immunity Test

Visual: work status and video quality

5 Equipment List

Conducted Emissions at Mains Terminals (150kHz-30MHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
EMI test receiver	Rohde & Schwarz	ESR7	SHEM162-1	2016-12-29	2017-12-28
Line impedance stabilization network	SCHWARZBECK	NSLK8127	SHEM061-1	2016-12-29	2017-12-28
Line impedance stabilization network	EMCO	3816/2	SHEM019-1	2016-12-29	2017-12-28
Pulse limiter	Rohde & Schwarz	ESH3-Z2	SHEM029-1	2016-08-12	2017-08-11
Shielding Room	ZHONGYU	8*4*3M	SHEM079-2	2016-08-17	2017-08-16

Radiated Emissions (30MHz-1GHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
EMI test receiver	Rohde & Schwarz	ESU40	SHEM051-1	2016-08-12	2017-08-11
CONTROLLER	INNCO	CO200	SHEM047-1	N/A	N/A
ANTENNA MAST	INNCO	MA400-EP	SHEM047-2	N/A	N/A
TURN DEVICE	INNCO	DE 3600-RH	SHEM047-3	N/A	N/A
Broadband UHF-VHF ANTENNA	SCHWARZBECK	VULB9168	SHEM048-1	2016-12-29	2017-12-28
Low Frequency Amplifier	CLAVIIO	BDLNA-0001-412010	SHEM164-1	2016-08-12	2017-08-11
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2016-08-17	2017-08-16

Radiated Emissions (above 1GHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
EMI test receiver	Rohde & Schwarz	ESU40	SHEM051-1	2016-08-12	2017-08-11
CONTROLLER	INNCO	CO200	SHEM047-1	N/A	N/A
ANTENNA MAST	INNCO	MA400-EP	SHEM047-2	N/A	N/A
TURN DEVICE	INNCO	DE 3600-RH	SHEM047-3	N/A	N/A
Double ridged broadband horn ANTENNA	SCHWARZBECK	BBHA9120D	SHEM050-1	2017-01-16	2018-01-15
High-amplifier	SCHWARZBECK	SCU-F0118-G40-BZ4-CS	SHEM050-2	2017-01-14	2018-01-13
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2016-08-17	2017-08-16

Voltage Fluctuations and Flicker					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Harmonic&Flicker analyzer	AMETEK	PACS-1	SHEM024-2	2016-09-06	2017-09-05
AC Power Source 5KVA	AMETEK	5001iX	SHEM025-2	2016-09-06	2017-09-05

Electrostatic Discharge					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Electrostatic Discharge Simulator	TESEQ	NSG 437	SHEM041-1	2016-08-15	2017-08-14

Radiated Immunity (80MHz-1GHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2016-12-29	2017-12-28
Power Meter	Rohde & Schwarz	NRP	SHEM057-1	2016-12-29	2017-12-28
Power meter sensor	Rohde & Schwarz	NRP-Z91	SHEM057-2	2016-12-29	2017-12-28
Antenna	SCHWARZBECK	STLP9128D	SHEM130-1	N/A	N/A
Amplifier	MILMEGA	AS0840-55-55	SHEM133-1	N/A	N/A
Power meter sensor	Rohde & Schwarz	NRP-Z22	SHEM136-1	2016-08-12	2017-08-11
ElectroMagnetic Field Probe	ETS-Lindgren	HI-6113	SHEM134-1	2016-08-12	2017-08-11
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2016-08-17	2017-08-16

Electrical Fast Transients/Burst at Power Port					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2016-12-29	2017-12-28
Matching resistors for EFT/burst generators	EM test	KW50	SHEM026-4	2016-12-29	2017-12-28
Matching resistors for EFT/burst generators	EM test	KW1000	SHEM026-5	2016-12-29	2017-12-28

Electrical Fast Transients/Burst at Signal Port					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2016-12-29	2017-12-28
Capacitive coupling clamp	EM test	HFK	SHEM026-2	2016-08-12	2017-08-11
Data coupling network 4 line	EM test	CNV 504	SHEM026-3	2016-08-12	2017-08-11
Matching resistors for EFT/burst generators	EM test	KW1000	SHEM026-5	2016-12-29	2017-12-28

Surge at Power Port					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2016-12-29	2017-12-28

Surge at Signal Port					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2016-12-29	2017-12-28
Data coupling network 4 line	EM test	CNV 504	SHEM026-3	2016-08-12	2017-08-11

Conducted Immunity at Power Port (150kHz-80MHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2016-12-29	2017-12-28
PAMP Conducted RF test system	HAEFFLY	PAMP250	SHEM023-1	2016-12-29	2017-12-28
6dB Attenuator	HUAXIANG	TST-150-761	SHEM151-1	N/A	N/A
Coupling clamp	LIITHI	EM 101	SHEM027-1	2016-12-29	2017-12-28
CDN impedance and K-factor	LUTHI	L-801 M1	SHEM023-5	2016-12-29	2017-12-28
CDN impedance and K-factor	LUTHI	L-801 M2/M3	SHEM023-6	2017-01-14	2018-01-13
Shielding Room	ZHONGYU	5*5*3M	SHEM079-6	2016-08-17	2017-08-16

Conducted Immunity at Signal Port (150kHz-80MHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2016-12-29	2017-12-28
PAMP Conducted RF test system	HAEFFLY	PAMP250	SHEM023-1	2016-12-29	2017-12-28
Coupling clamp	LIITHI	EM 101	SHEM027-1	2016-12-29	2017-12-28
Shielding Room	ZHONGYU	5*5*3M	SHEM079-6	2016-08-17	2017-08-16

Voltage Dips and Interruptions					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2016-12-29	2017-12-28

Mains Supply Voltage Variations-Conditioning					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2016-12-29	2017-12-28

Radiated Immunity(80MHz-2.7GHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2016-12-29	2017-12-28
Power Meter	Rohde & Schwarz	NRP	SHEM057-1	2016-12-29	2017-12-28
Power meter sensor	Rohde & Schwarz	NRP-Z91	SHEM057-2	2016-12-29	2017-12-28
Antenna	SCHWARZBECK	STLP9128D	SHEM130-1	N/A	N/A
Antenna	SCHWARZBECK	STLP9149	SHEM131-1	N/A	N/A
Amplifier	MILMEGA	80RF1000-250	SHEM132-1	N/A	N/A
Amplifier	MILMEGA	AS0840-55-55	SHEM133-1	N/A	N/A
Power meter sensor	Rohde & Schwarz	NRP-Z22	SHEM136-1	2016-08-12	2017-08-11
ElectroMagnetic Field Probe	ETS-Lindgren	HI-6113	SHEM134-1	2016-08-12	2017-08-11
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2016-08-17	2017-08-16

Conducted Immunity at Power Port (150kHz-100MHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2016-12-29	2017-12-28
PAMP Conducted RF test system	HAEFFLY	PAMP250	SHEM023-1	2016-12-29	2017-12-28
6dB Attenuator	HUAXIANG	TST-150-761	SHEM151-1	N/A	N/A
CDN impedance and K-factor	LUTHI	L-801 M1	SHEM023-5	2016-12-29	2017-12-28
CDN impedance and K-factor	LUTHI	L-801 M2/M3	SHEM023-6	2017-01-14	2018-01-13
Shielding Room	ZHONGYU	5*5*3M	SHEM079-6	2016-08-17	2017-08-16

General used equipment					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Digital pressure meter	YONGZHI	DYM3-01	SHEM082-1	2017-03-03	2018-03-02
Temperature&humidity recorder	ShangHai weather meter work	ZJ 1-2B	SHEM042-1~6	2016-08-19	2017-08-18
Digital Multimeter	FLUKE	17B	SHEM043-5	2016-08-15	2017-08-14
Autoformer regulator	Guangzhou bao de	TDGC2-5KVA	SHEM150-1	N/A	N/A
Multi-purpose tong tester	FLUKE	316	SHEM001-1	2017-01-29	2018-01-28

6 Emission Test Results

6.1 Conducted Emissions at Mains Terminals (150kHz-30MHz)

Test Requirement:	EN 55032:2015
Test Method:	EN 55032:2015
Frequency Range:	150kHz to 30MHz
Limit:	
0.15M-0.5MHz	66dB(μV)-56dB(μV) quasi-peak, 56dB(μV)-46dB(μV) average
0.5M-5MHz	56dB(μV) quasi-peak, 46dB(μV) average
5M-30MHz	60dB(μV) quasi-peak, 50dB(μV) average
Detector:	Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

6.1.1 E.U.T. Operation

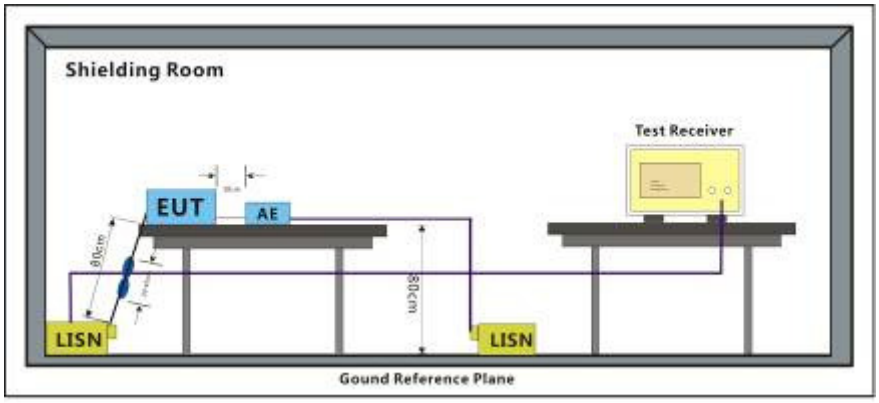
Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

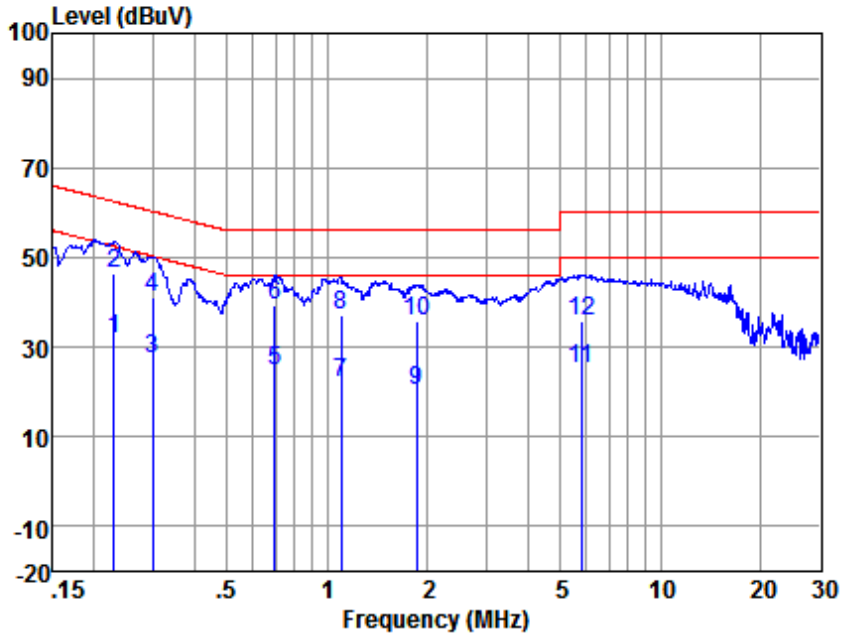
6.1.2 Test Setup Diagram



6.1.3 Measurement Data

An initial pre-scan was performed with peak detector.Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.

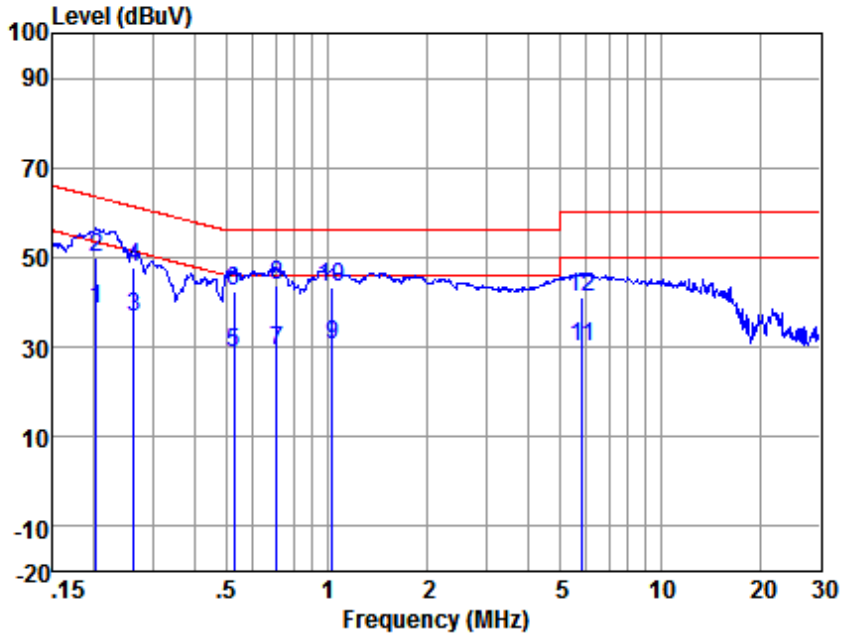
Mode:a, Line:Live Line



Site : chamber
Condition : LISN-L-2016
EUT/Project No: 4210IT
Test mode : a

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.229	21.86	0.09	9.81	31.76	52.48	-20.72	Average
2	0.229	36.62	0.09	9.81	46.52	62.48	-15.96	QP
3	0.300	17.58	0.09	9.81	27.48	50.24	-22.76	Average
4	0.300	31.01	0.09	9.81	40.91	60.24	-19.33	QP
5	0.697	14.86	0.10	9.83	24.79	46.00	-21.21	Average
6	0.697	29.29	0.10	9.83	39.22	56.00	-16.78	QP
7	1.100	12.30	0.08	9.84	22.22	46.00	-23.78	Average
8	1.100	27.09	0.08	9.84	37.01	56.00	-18.99	QP
9	1.858	10.28	0.08	9.85	20.21	46.00	-25.79	Average
10	1.858	25.81	0.08	9.85	35.74	56.00	-20.26	QP
11	5.805	15.12	0.16	9.86	25.14	50.00	-24.86	Average
12	5.805	25.62	0.16	9.86	35.64	60.00	-24.36	QP

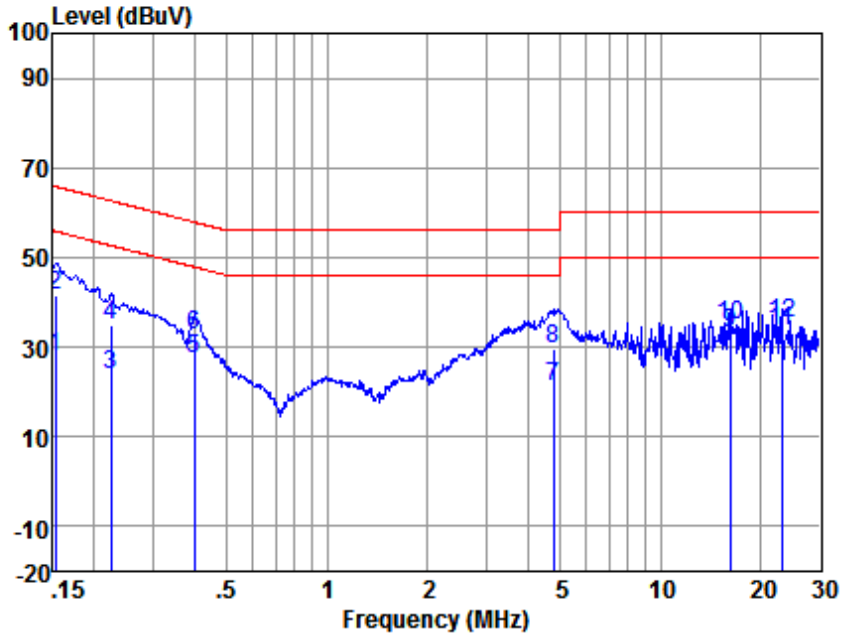
Mode:a, Line:Neutral Line



Site : chamber
Condition : LISN-N-2016
EUT/Project No: 4210IT
Test mode : a

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.202	28.53	0.05	9.81	38.39	53.54	-15.15	Average
2	0.202	40.16	0.05	9.81	50.02	63.54	-13.52	QP
3	0.263	26.66	0.05	9.81	36.52	51.34	-14.82	Average
4	0.263	38.08	0.05	9.81	47.94	61.34	-13.40	QP
5	0.524	18.72	0.04	9.82	28.58	46.00	-17.42	Average
6	0.524	32.50	0.04	9.82	42.36	56.00	-13.64	QP
7	0.705	19.29	0.05	9.83	29.17	46.00	-16.83	Average
8	0.705	33.87	0.05	9.83	43.75	56.00	-12.25	QP
9	1.037	20.65	0.05	9.84	30.54	46.00	-15.46	Average
10	1.037	33.36	0.05	9.84	43.25	56.00	-12.75	QP
11	5.836	20.02	0.18	9.86	30.06	50.00	-19.94	Average
12	5.836	30.99	0.18	9.86	41.03	60.00	-18.97	QP

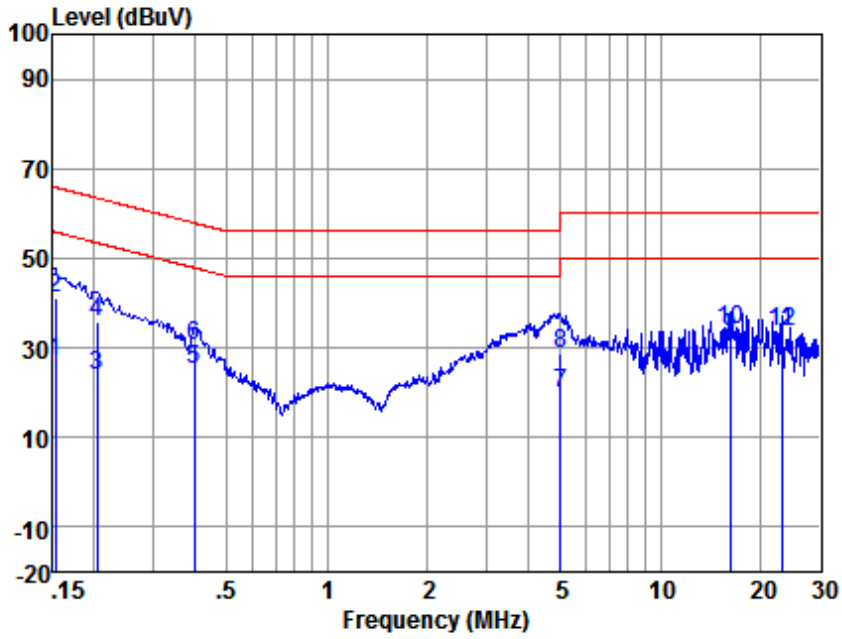
Mode:b, Line:Live Line



Site : chamber
Condition : LISN-L-2016
EUT/Project No: 4210IT
Test mode : b

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.152	17.77	0.05	9.81	27.63	55.87	-28.24	Average
2	0.152	31.73	0.05	9.81	41.59	65.87	-24.28	QP
3	0.224	14.07	0.09	9.81	23.97	52.66	-28.69	Average
4	0.224	25.05	0.09	9.81	34.95	62.66	-27.71	QP
5	0.400	17.64	0.10	9.82	27.56	47.86	-20.30	Average
6	0.400	22.78	0.10	9.82	32.70	57.86	-25.16	QP
7	4.772	10.99	0.15	9.86	21.00	46.00	-25.00	Average
8	4.772	19.59	0.15	9.86	29.60	56.00	-26.40	QP
9	16.226	22.71	0.23	10.02	32.96	50.00	-17.04	Average
10	16.226	24.61	0.23	10.02	34.86	60.00	-25.14	QP
11	23.140	23.07	0.35	10.04	33.46	50.00	-16.54	Average
12	23.140	24.97	0.35	10.04	35.36	60.00	-24.64	QP

Mode:b, Line:Neutral Line



Site : chamber
Condition : LISN-N-2016
EUT/Project No: 4210IT
Test mode : b

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.152	17.26	0.05	9.81	27.12	55.87	-28.75	Average
2	0.152	31.05	0.05	9.81	40.91	65.87	-24.96	QP
3	0.204	14.08	0.05	9.81	23.94	53.45	-29.51	Average
4	0.204	26.00	0.05	9.81	35.86	63.45	-27.59	QP
5	0.400	15.51	0.04	9.82	25.37	47.86	-22.49	Average
6	0.400	20.67	0.04	9.82	30.53	57.86	-27.33	QP
7	5.031	9.94	0.18	9.86	19.98	50.00	-30.02	Average
8	5.031	18.46	0.18	9.86	28.50	60.00	-31.50	QP
9	16.226	21.89	0.27	10.02	32.18	50.00	-17.82	Average
10	16.226	23.81	0.27	10.02	34.10	60.00	-25.90	QP
11	23.140	23.11	0.35	10.04	33.50	50.00	-16.50	Average
12	23.140	23.10	0.35	10.04	33.49	60.00	-26.51	QP

6.2 Asymmetric Mode Conducted Emissions (150kHz-30MHz)

Test Requirement:	EN 55032:2015
Test Method:	EN 55032:2015
Limit:	
0.15M-0.5MHz(Voltage)	84-74(dBμV) quasi-peak, 74-64(dBμV) average
0.5M-30MHz(Voltage)	74(dBμV) quasi-peak, 64(dBμV) average
0.15M-0.5MHz(Current)	40-30(dBμV) quasi-peak, 30-20(dBμV) average
0.5M-30MHz(Current)	30(dBμV) quasi-peak, 20(dBμV) average
Detector:	9kHz resolution bandwidth 0.15M to 30MHz
Remark:	The voltage measured shall be corrected at each frequency of interest as follows: if the current margin with respect to the current limit is ⩽ 6 dB, the actual current margin shall be subtracted from the measured voltage, if the current margin with respect to the current limit is > 6 dB, 6 dB shall be subtracted from the measured voltage.

6.2.1 E.U.T. Operation

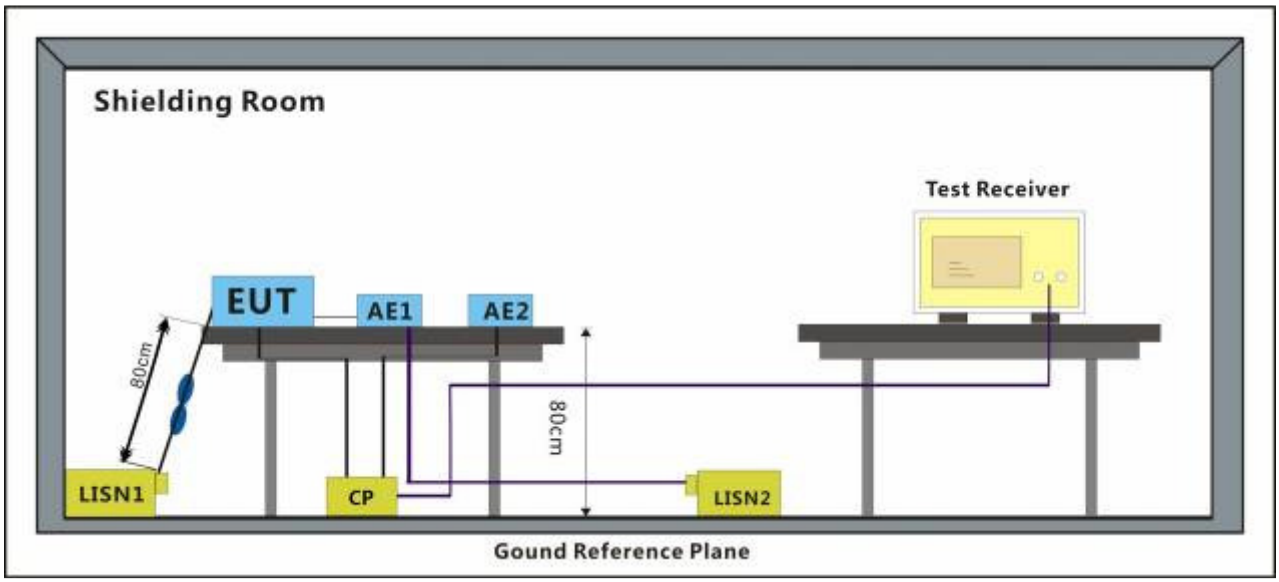
Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

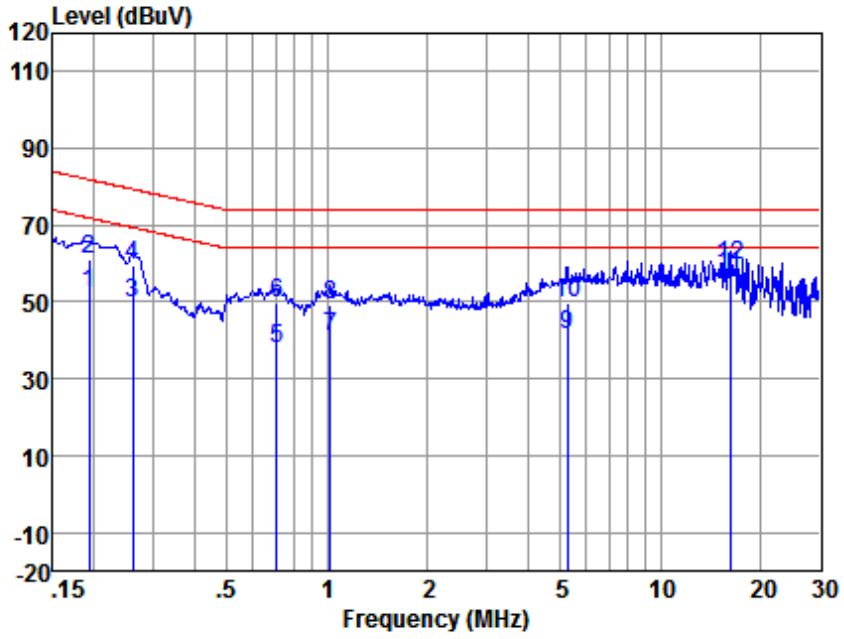
b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

6.2.2 Test Setup Diagram



6.2.3 Measurement Data

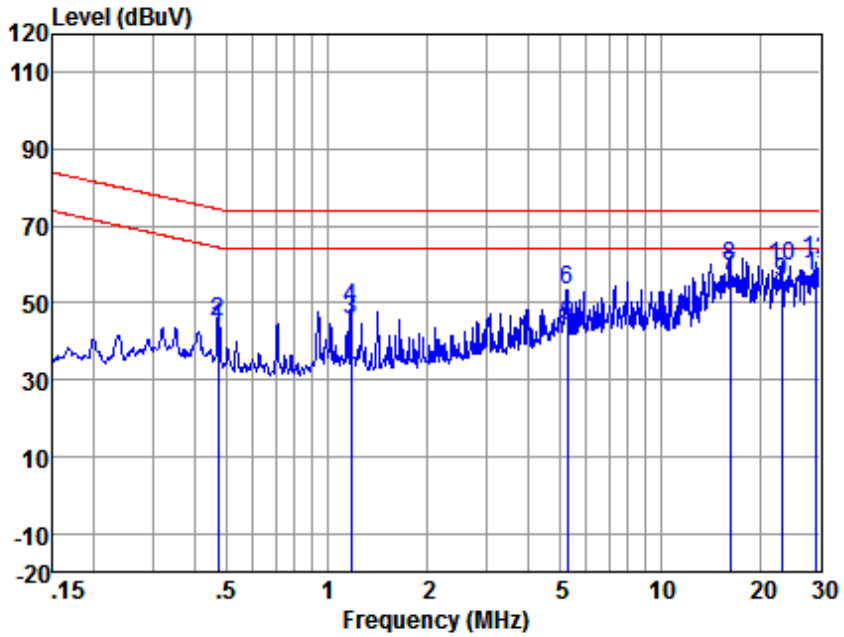
Mode:a



Site : chamber
Condition : ISN CAT5
Model number: 4210IT
Test mode : a

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.192	32.66	9.67	9.81	52.14	71.93	-19.79	Average
2	0.192	41.83	9.67	9.81	61.31	81.93	-20.62	QP
3	0.260	30.23	9.59	9.81	49.63	69.42	-19.79	Average
4	0.260	40.07	9.59	9.81	59.47	79.42	-19.95	QP
5	0.705	18.54	9.39	9.83	37.76	64.00	-26.24	Average
6	0.705	30.49	9.39	9.83	49.71	74.00	-24.29	QP
7	1.021	21.98	9.34	9.84	41.16	64.00	-22.84	Average
8	1.021	30.18	9.34	9.84	49.36	74.00	-24.64	QP
9	5.249	22.52	9.20	9.86	41.58	64.00	-22.42	Average
10	5.249	30.60	9.20	9.86	49.66	74.00	-24.34	QP
11	16.226	37.49	9.25	10.02	56.76	64.00	-7.24	Average
12	16.226	40.33	9.25	10.02	59.60	74.00	-14.40	QP

Mode:b



Site : chamber
Condition : ISN CAT5
Model number: 4210IT
Test mode : b

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.471	24.44	9.46	9.82	43.72	64.49	-20.77	Average
2	0.471	25.73	9.46	9.82	45.01	74.49	-29.48	QP
3	1.178	26.46	9.33	9.84	45.63	64.00	-18.37	Average
4	1.178	29.57	9.33	9.84	48.74	74.00	-25.26	QP
5	5.249	25.12	9.20	9.86	44.18	64.00	-19.82	Average
6	5.249	34.52	9.20	9.86	53.58	74.00	-20.42	QP
7	16.226	37.69	9.25	10.02	56.96	64.00	-7.04	Average
8	16.226	40.04	9.25	10.02	59.31	74.00	-14.69	QP
9	23.140	36.28	9.35	10.04	55.67	64.00	-8.33	Average
10	23.140	40.21	9.35	10.04	59.60	74.00	-14.40	QP
11	29.527	37.55	9.44	10.13	57.12	64.00	-6.88	Average
12	29.527	41.77	9.44	10.13	61.34	74.00	-12.66	QP

6.1 Radiated Emissions (30MHz-1GHz)

Test Requirement:	EN 55032:2015
Test Method:	EN 55032:2015
Frequency Range:	30MHz to 1GHz
Measurement Distance:	3m
Limit:	
30MHz-230MHz	40 dB(μV/m) quasi-peak
230MHz-1GHz	47 dB(μV/m) quasi-peak
Detector:	Peak for pre-scan (120kHz resolution bandwidth) 30M to 1000MHz

6.1.1 E.U.T. Operation

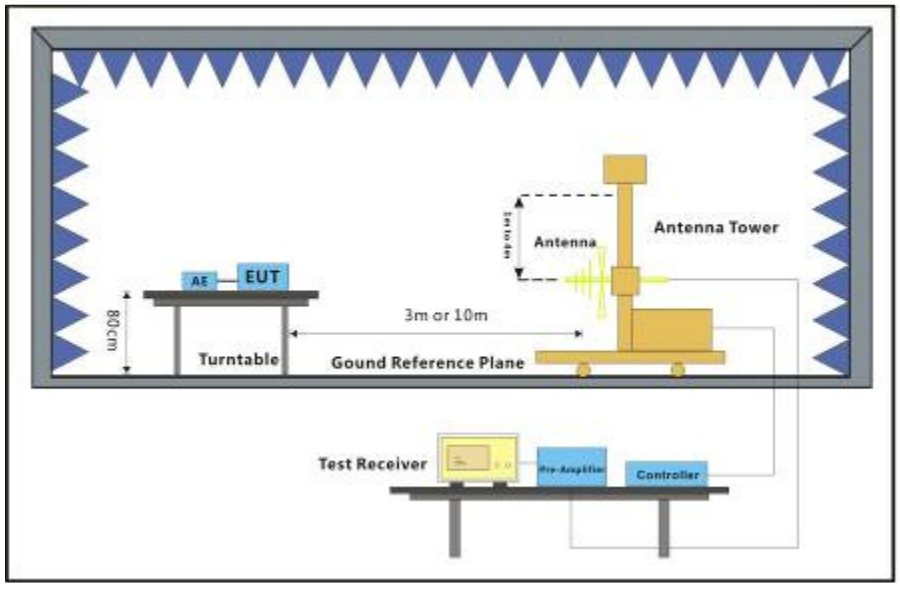
Operating Environment:

Temperature: 20 °C Humidity: 50 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

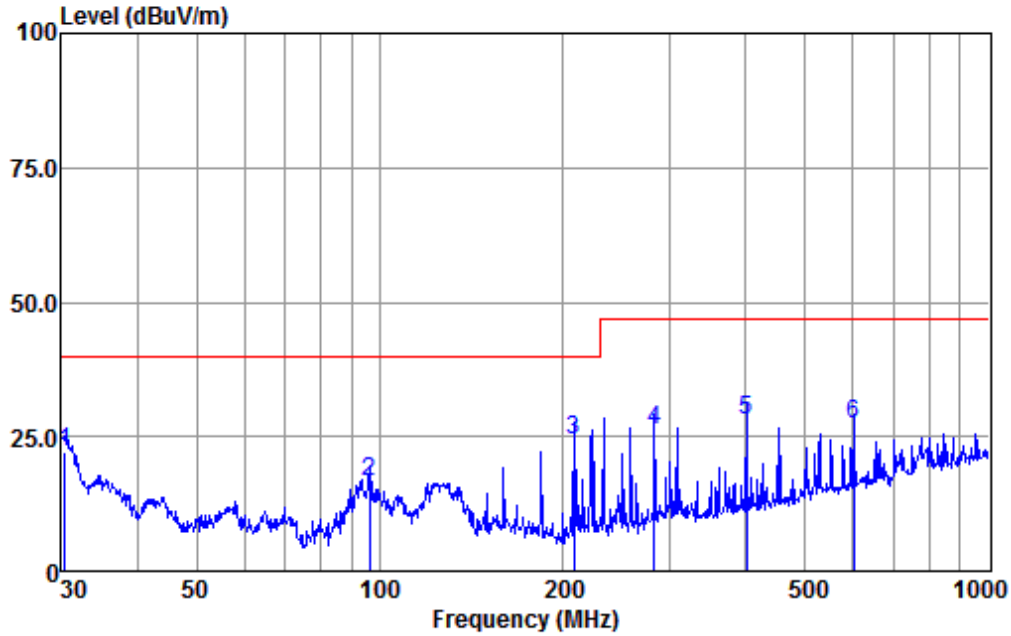
6.1.2 Test Setup Diagram



6.1.3 Measurement Data

An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.

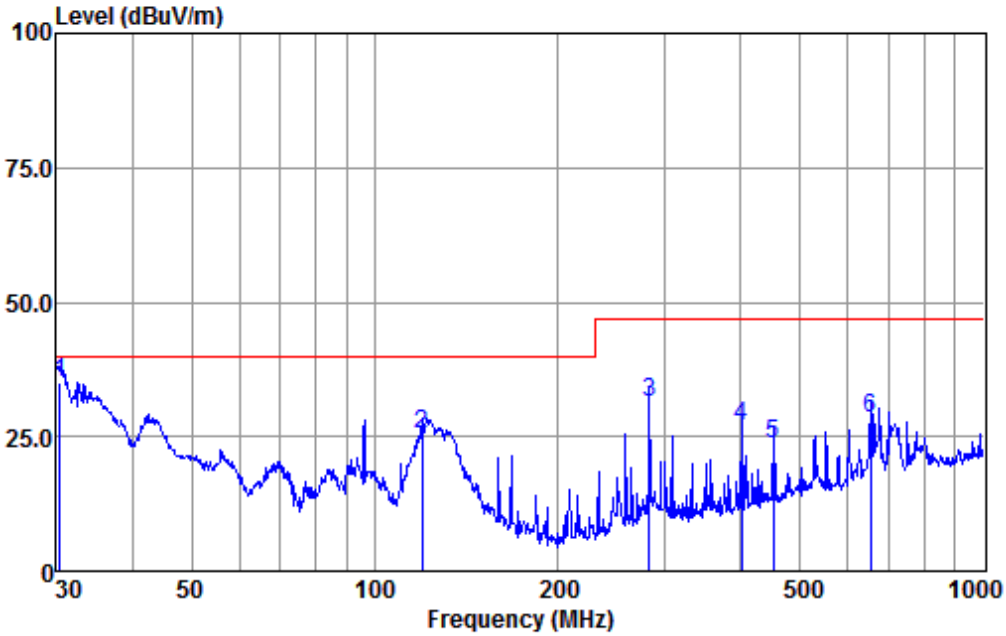
Mode:a, Polarization:Horizontal



Condition : HORIZONTAL
EUT/Project: 4210IT
Test mode : a

	Freq	Read Level	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	30.42	49.31	15.35	0.18	42.67	22.17	40.00	-17.83	QP
2	96.10	49.94	8.99	0.44	42.70	16.67	40.00	-23.33	QP
3 q	208.58	56.51	9.79	0.71	42.48	24.53	40.00	-15.47	QP
4	282.99	55.13	12.64	0.82	42.37	26.22	47.00	-20.78	QP
5	400.43	54.14	15.10	1.00	42.09	28.15	47.00	-18.85	QP
6	601.43	48.57	19.42	1.38	42.19	27.18	47.00	-19.82	QP

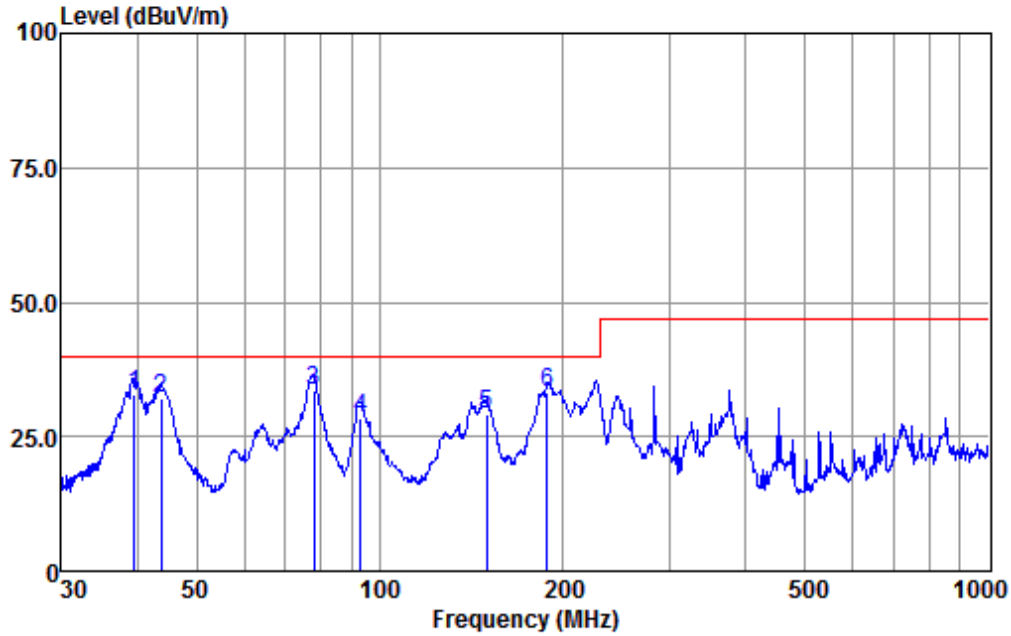
Mode:a, Polarization:Vertical



Condition : VERTICAL
EUT/Project: 4210IT
Test mode : a

	Freq	Read Level	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1 q	30.42	62.03	15.35	0.18	42.67	34.89	40.00	-5.11	QP
2	119.86	57.68	10.00	0.54	42.67	25.55	40.00	-14.45	QP
3	282.99	60.14	12.64	0.82	42.37	31.23	47.00	-15.77	QP
4	400.43	52.78	15.10	1.00	42.09	26.79	47.00	-20.21	QP
5	451.14	48.30	16.23	1.09	42.07	23.55	47.00	-23.45	QP
6	651.94	49.28	19.84	1.51	42.22	28.41	47.00	-18.59	QP

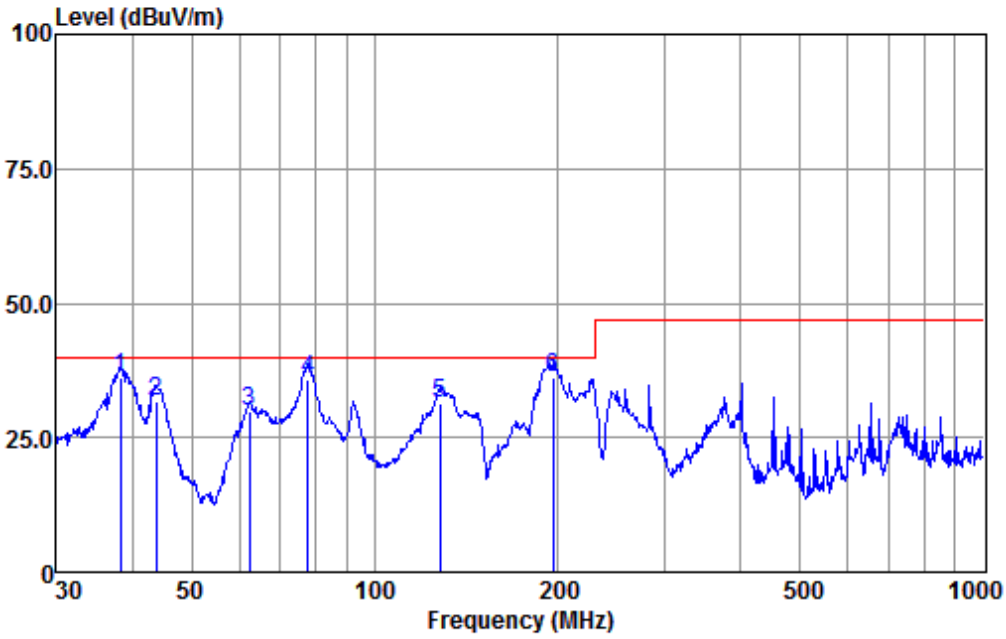
Mode:b, Polarization:Horizontal



Condition : HORIZONTAL
EUT/Project: 4210IT
Test mode : b

	Freq	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	39.58	59.06	16.26	0.22	42.68	32.86	40.00	-7.14	QP
2	43.81	60.40	13.98	0.23	42.68	31.93	40.00	-8.07	QP
3 q	78.14	67.15	8.63	0.37	42.69	33.46	40.00	-6.54	QP
4	93.11	62.24	8.57	0.43	42.70	28.54	40.00	-11.46	QP
5	150.01	59.18	11.90	0.62	42.58	29.12	40.00	-10.88	QP
6	188.41	64.53	10.51	0.68	42.51	33.21	40.00	-6.79	QP

Mode:b, Polarization:Vertical



Condition : VERTICAL
EUT/Project: 4210IT
Test mode : b

	Freq	Read Level	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	38.21	62.30	16.14	0.22	42.68	35.98	40.00	-4.02	QP
2	43.81	60.31	13.98	0.23	42.68	31.84	40.00	-8.16	QP
3	62.21	59.81	12.33	0.30	42.69	29.75	40.00	-10.25	QP
4	77.59	69.19	8.81	0.37	42.69	35.68	40.00	-4.32	QP
5	128.11	61.02	12.31	0.57	42.63	31.27	40.00	-8.73	QP
6 q	196.51	68.21	9.70	0.69	42.50	36.10	40.00	-3.90	QP

6.2 Radiated Emissions (above 1GHz)

Test Requirement:	EN 55032:2015
Test Method:	EN 55032:2015
Frequency Range:	Above 1GHz
Measurement Distance:	3m
Limit:	
1GHz-3GHz	70 dB(μV/m) peak, 50 dB(μV/m) average
3GHz-6GHz	74 dB(μV/m) peak, 54dB(μV/m) average
Detector:	Peak for pre-scan (1000kHz resolution bandwidth) 1000M to 6000MHz

6.2.1 E.U.T. Operation

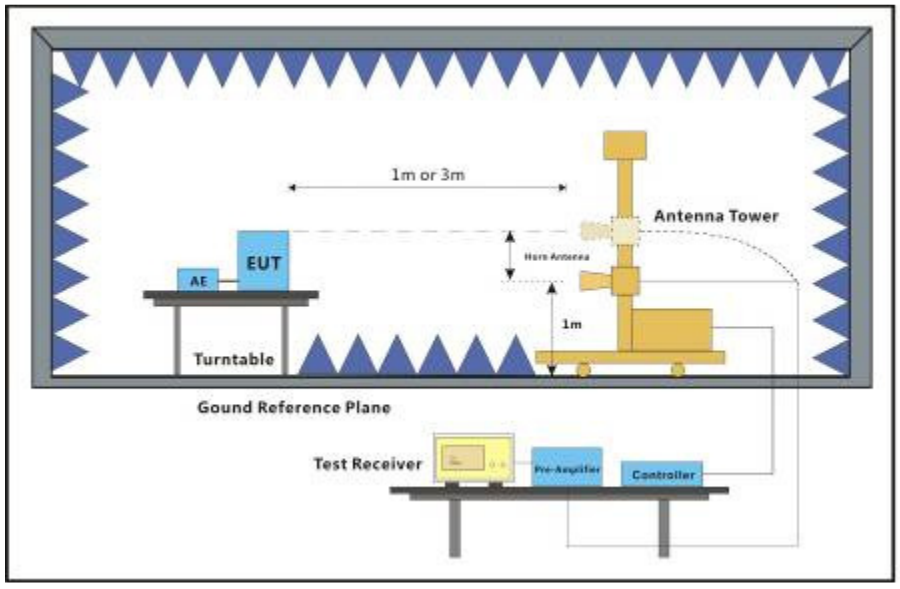
Operating Environment:

Temperature: 20 °C Humidity: 50 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

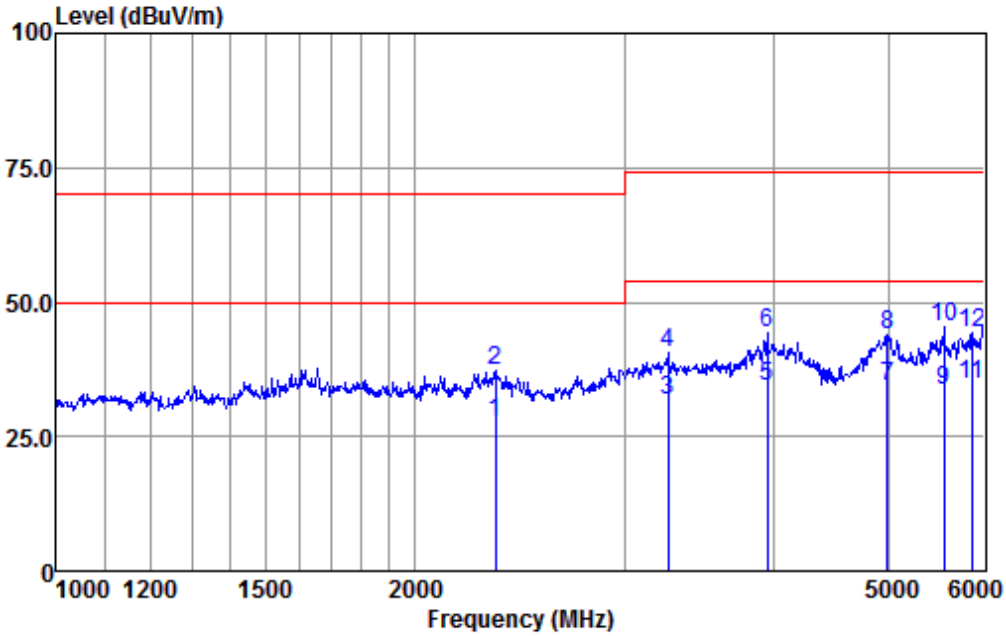
6.2.2 Test Setup Diagram



6.2.3 Measurement Data

An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.

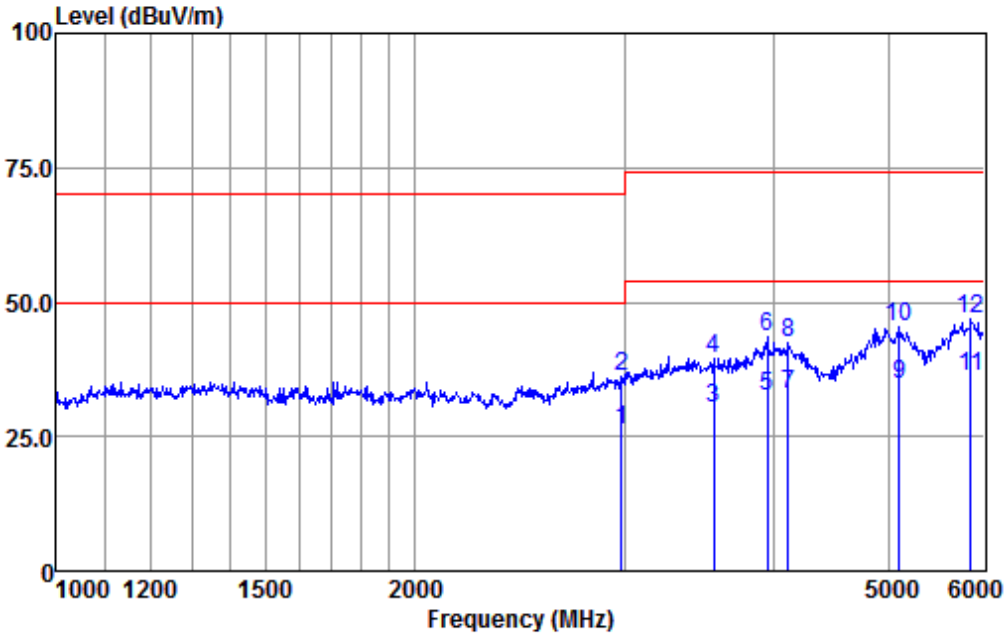
Mode:a, Polarization:Horizontal



Condition : HORIZONTAL
EUT/Project: 4210IT
Test Mode : a

	Freq	ReadLevel	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	2338.00	37.87	26.98	5.07	42.18	27.74	50.00	-22.26	Average
2	2338.00	47.28	26.98	5.07	42.18	37.15	70.00	-32.85	Peak
3	3262.72	38.95	28.66	6.02	41.79	31.84	54.00	-22.16	Average
4	3262.72	47.71	28.66	6.02	41.79	40.60	74.00	-33.40	Peak
5	3952.23	39.84	29.60	6.99	41.95	34.48	54.00	-19.52	Average
6	3952.23	49.53	29.60	6.99	41.95	44.17	74.00	-29.83	Peak
7	4988.86	36.14	31.57	8.19	41.61	34.29	54.00	-19.71	Average
8	4988.86	45.85	31.57	8.19	41.61	44.00	74.00	-30.00	Peak
9	5565.05	35.42	31.99	8.32	41.99	33.74	54.00	-20.26	Average
10 p	5565.05	47.07	31.99	8.32	41.99	45.39	74.00	-28.61	Peak
11	5872.37	35.69	32.41	8.40	41.88	34.62	54.00	-19.38	Average
12	5872.37	45.29	32.41	8.40	41.88	44.22	74.00	-29.78	Peak

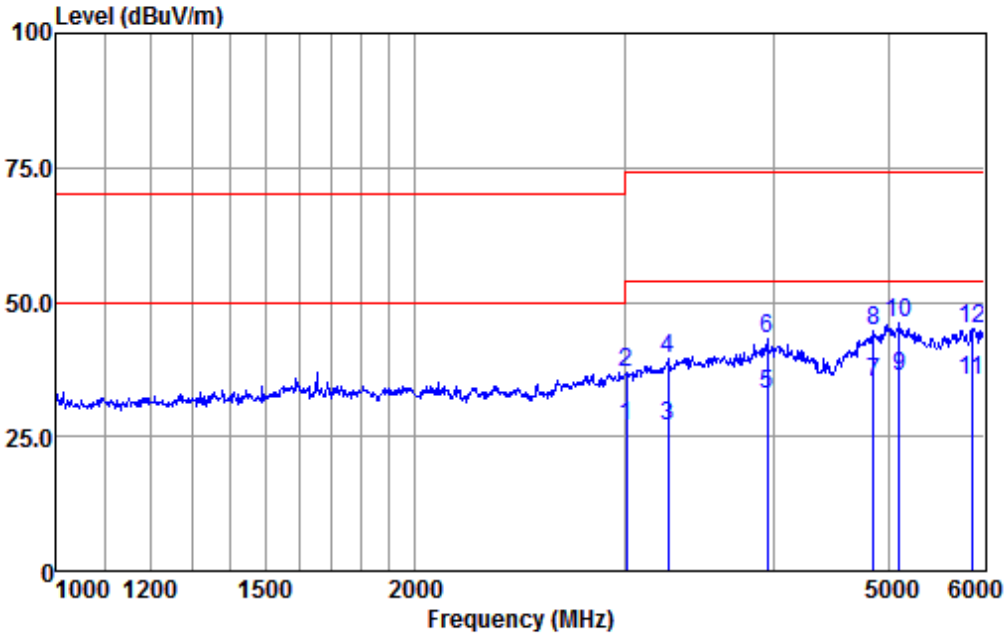
Mode:a, Polarization:Vertical



Condition : VERTICAL
EUT/Project: 4210IT
Test Mode : a

	Freq	ReadLevel	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	2983.13	33.84	28.47	5.79	41.72	26.38	50.00	-23.62	Average
2	2983.13	43.53	28.47	5.79	41.72	36.07	70.00	-33.93	Peak
3	3562.13	36.73	28.93	6.33	41.87	30.12	54.00	-23.88	Average
4	3562.13	46.14	28.93	6.33	41.87	39.53	74.00	-34.47	Peak
5	3952.23	37.76	29.60	6.99	41.95	32.40	54.00	-21.60	Average
6	3952.23	48.99	29.60	6.99	41.95	43.63	74.00	-30.37	Peak
7	4118.50	37.66	29.93	7.22	41.88	32.93	54.00	-21.07	Average
8	4118.50	47.30	29.93	7.22	41.88	42.57	74.00	-31.43	Peak
9	5097.29	36.57	31.65	8.21	41.68	34.75	54.00	-19.25	Average
10	5097.29	47.18	31.65	8.21	41.68	45.36	74.00	-28.64	Peak
11	5861.86	37.26	32.41	8.40	41.88	36.19	54.00	-17.81	Average
12 p	5861.86	47.85	32.41	8.40	41.88	46.78	74.00	-27.22	Peak

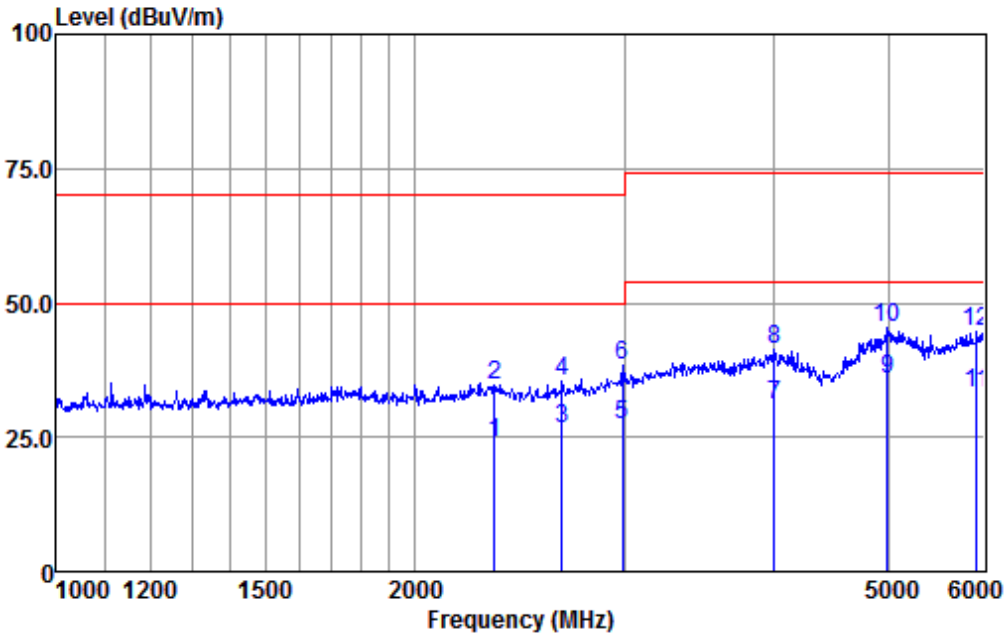
Mode:b, Polarization:Horizontal



Condition : HORIZONTAL
EUT/Project: 4210IT
Test Mode : b

	Freq	ReadLevel	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	3009.98	34.34	28.51	5.83	41.71	26.97	54.00	-27.03	Average
2	3009.98	44.40	28.51	5.83	41.71	37.03	74.00	-36.97	Peak
3	3262.72	34.20	28.66	6.02	41.79	27.09	54.00	-26.91	Average
4	3262.72	46.49	28.66	6.02	41.79	39.38	74.00	-34.62	Peak
5	3952.23	38.12	29.60	6.99	41.95	32.76	54.00	-21.24	Average
6	3952.23	48.48	29.60	6.99	41.95	43.12	74.00	-30.88	Peak
7	4856.57	37.26	31.33	8.15	41.62	35.12	54.00	-18.88	Average
8	4856.57	46.71	31.33	8.15	41.62	44.57	74.00	-29.43	Peak
9	5097.29	37.94	31.65	8.21	41.68	36.12	54.00	-17.88	Average
10 p	5097.29	47.81	31.65	8.21	41.68	45.99	74.00	-28.01	Peak
11	5872.37	36.54	32.41	8.40	41.88	35.47	54.00	-18.53	Average
12	5872.37	46.22	32.41	8.40	41.88	45.15	74.00	-28.85	Peak

Mode:b, Polarization:Vertical

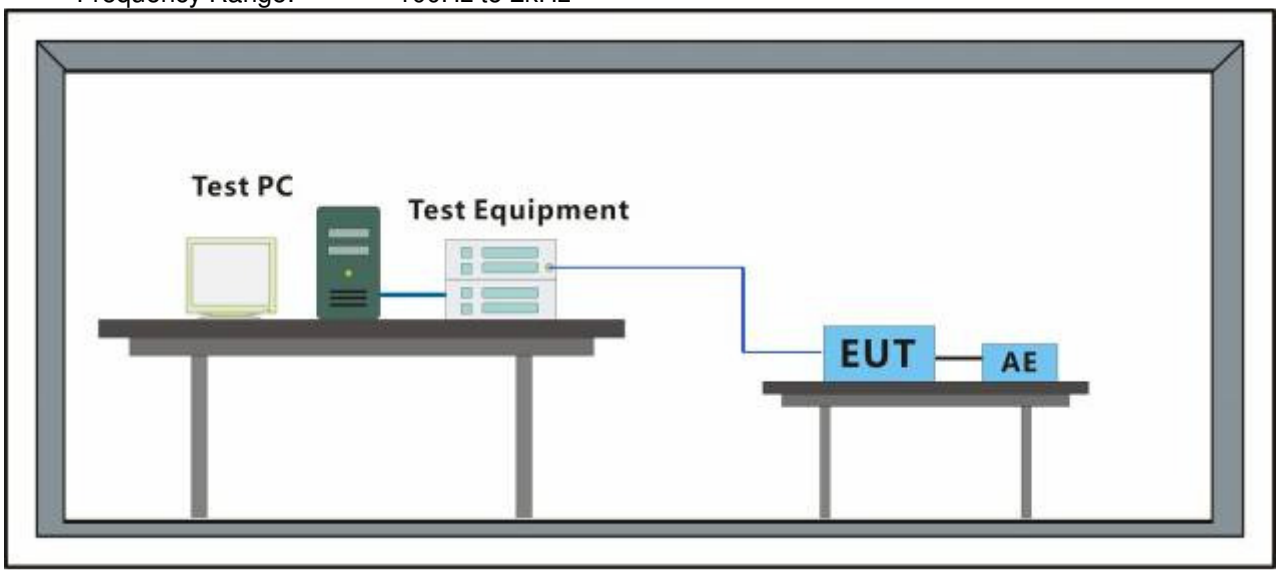


Condition : VERTICAL
EUT/Project: 4210IT
Test Mode : b

	Freq	Read Level	Antenna Factor	Cable Loss	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	2333.81	34.07	26.96	5.07	42.19	23.91	50.00	-26.09	Average
2	2333.81	44.95	26.96	5.07	42.19	34.79	70.00	-35.21	Peak
3	2659.93	35.16	27.77	5.52	42.02	26.43	50.00	-23.57	Average
4	2659.93	44.07	27.77	5.52	42.02	35.34	70.00	-34.66	Peak
5	2988.48	34.75	28.48	5.79	41.72	27.30	50.00	-22.70	Average
6	2988.48	45.70	28.48	5.79	41.72	38.25	70.00	-31.75	Peak
7	4009.29	36.43	29.70	6.99	41.96	31.16	54.00	-22.84	Average
8	4009.29	46.42	29.70	6.99	41.96	41.15	74.00	-32.85	Peak
9	4988.86	37.75	31.57	8.19	41.61	35.90	54.00	-18.10	Average
10 p	4988.86	47.34	31.57	8.19	41.61	45.49	74.00	-28.51	Peak
11	5925.22	34.04	32.51	8.40	41.85	33.10	54.00	-20.90	Average
12	5925.22	45.41	32.51	8.40	41.85	44.47	74.00	-29.53	Peak

6.3 Harmonic Current Emission

Test Requirement: EN 61000-3-2:2014
Test Method: EN 61000-3-2:2014
Frequency Range: 100Hz to 2kHz



6.3.1 Measurement Data

There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2:2014.

For further details, please refer to Clause 7 of EN 61000-3-2 which states:

"For the following categories of equipment, limits are not specified in this standard.- equipment with a rated power of 75W or less, other than lighting equipment."

6.4 Voltage Fluctuations and Flicker

Test Requirement: EN 61000-3-3:2013

Test Method: EN 61000-3-3:2013

6.4.1 E.U.T. Operation

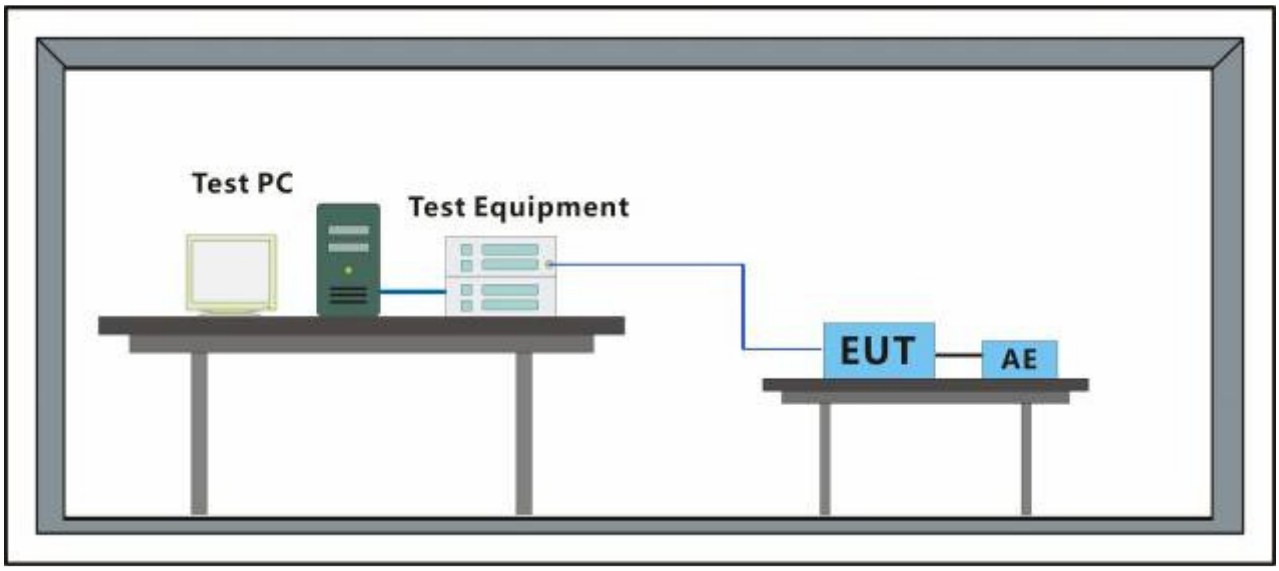
Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

6.4.2 Test Setup Diagram



6.4.3 Measurement Data

Mode:a

Parameter values recorded during the test:

Vrms at the end of test (Volt):	229.79			
T-max (mS):	0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.75	Test limit (%):	3.30	Pass
Highest dmax (%):	0.89	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.381	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.162	Test limit:	0.650	Pass

Mode:b

Parameter values recorded during the test:

Vrms at the end of test (Volt):	229.79			
T-max (mS):	0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.80	Test limit (%):	3.30	Pass
Highest dmax (%):	0.98	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.405	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.177	Test limit:	0.650	Pass

7 Immunity Test Results

7.1 Performance Criteria Description in EN 55024:2010 +A1:2015

Criterion A The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Criterion B After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Criterion C Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

7.2 Performance Criteria Description in EN 50130-4:2011 +A1:2014

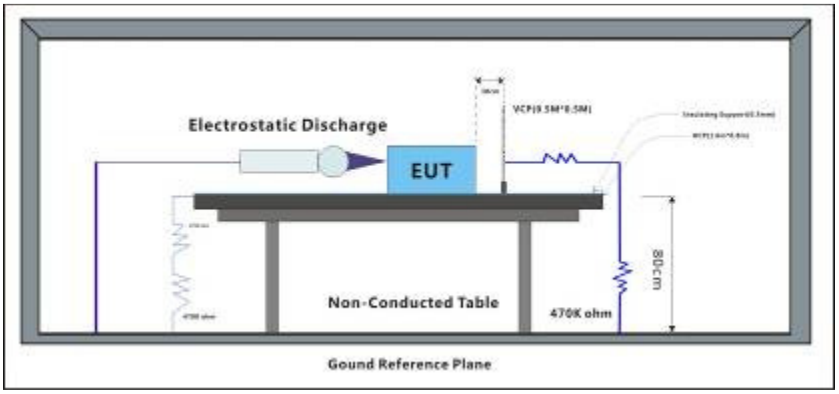
There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

For further details, please refer to Clause 7.4, 8.4, 9.4, 10.4, 11.4, 12.4 and 13.4, of EN 50130-4.

7.3 Electrostatic Discharge

Test Requirement: EN 55024:2010 +A1:2015
Test Method: EN 61000-4-2:2009
Performance Criterion: B
Discharge Impedance: 330Ω/150pF
Number of Discharge: Minimum of four test points (a minimum of 50 discharges at each point)
Discharge Mode: Single Discharge
Discharge Period: 1 second minimum

7.3.1 Test Setup Diagram



7.3.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .
b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.3.3 Test Results:

Observations: Test Point:

1. All insulated enclosure and seams.
2. All accessible metal parts of the enclosure.
3. All side

Discharge type	Level (kV)	Polarity	Test Point	Result / Observations
Air Discharge	2,4,8	+	1	A
Air Discharge	2,4,8	-	1	A
Contact Discharge	4	+	2	A
Contact Discharge	4	-	2	A
Horizontal Coupling	4	+	3	A
Horizontal Coupling	4	-	3	A
Vertical Coupling	4	+	3	A
Vertical Coupling	4	-	3	A

Results:

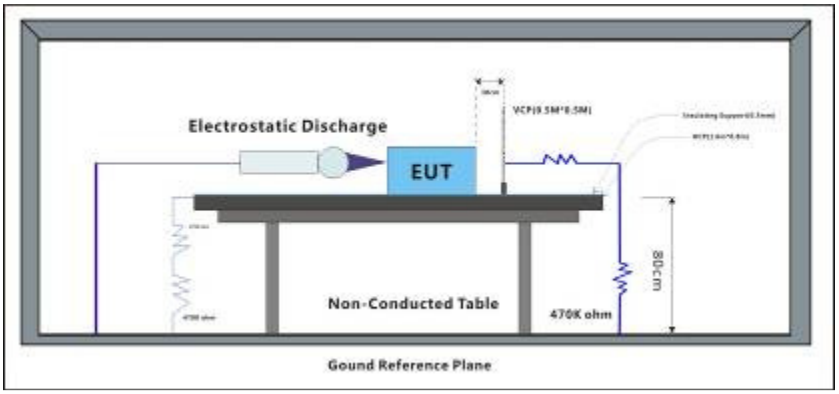
A: No degradation in the performance of the EUT was observed.

7.4 Electrostatic Discharge

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 61000-4-2:2009

7.4.1 Test Setup Diagram



7.4.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.4.3 Test Results:

Observations: Test Point:

1. All insulated enclosure and seams.
2. All accessible metal parts of the enclosure.
3. All side

Discharge type	Level (kV)	Polarity	Test Point	Result / Observations
Air Discharge	2,4,8	+	1	A
Air Discharge	2,4,8	-	1	A
Contact Discharge	6	+	2	A
Contact Discharge	6	-	2	A
Horizontal Coupling	6	+	3	A
Horizontal Coupling	6	-	3	A
Vertical Coupling	6	+	3	A
Vertical Coupling	6	-	3	A

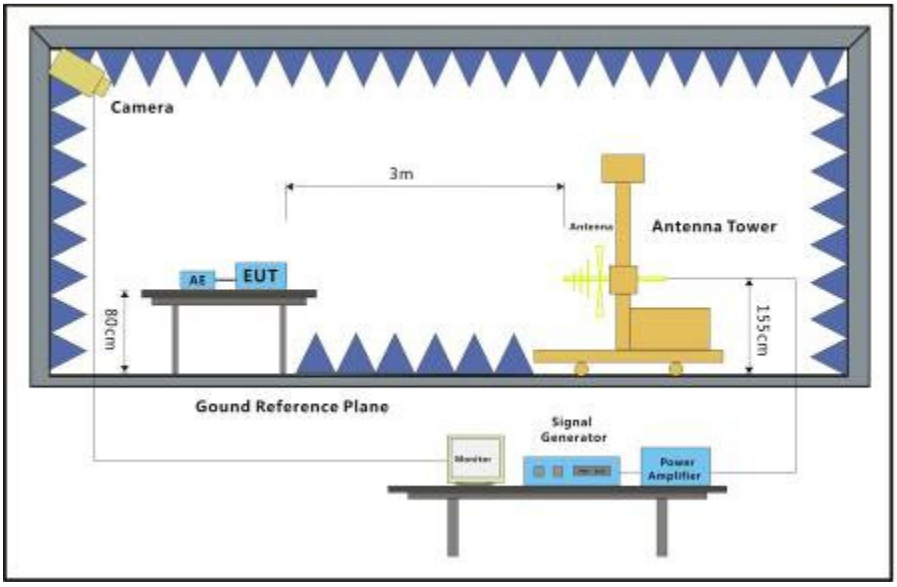
Results:

A: No degradation in the performance of the EUT was observed.

7.5 Radiated Immunity (80MHz-1GHz)

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-3:2006 +A1:2008+A2:2010
Performance Criterion:	A
Frequency Range:	80MHz to 1GHz
Antenna Polarisation:	Vertical and Horizontal
Modulation	1kHz,80% Amp. Mod,1% increment

7.5.1 Test Setup Diagram



7.5.2 E.U.T. Operation

Operating Environment:

Temperature: 20 °C Humidity: 50 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.5.3 Test Results:

Frequency	Level (V/m)	EUT Face	Dwell time	Result / Observations
80MHz-1GHz	3	Front	2s	A
80MHz-1GHz	3	Back	2s	A
80MHz-1GHz	3	Left	2s	A
80MHz-1GHz	3	Right	2s	A
80MHz-1GHz	3	Top	2s	A
80MHz-1GHz	3	Underside	2s	A

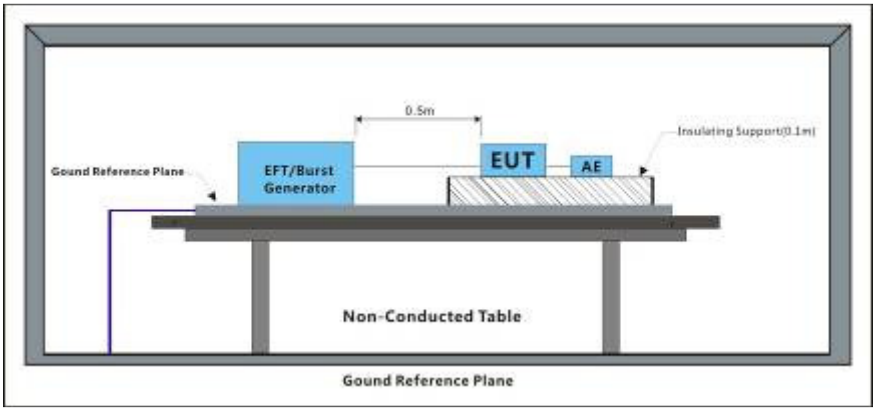
Results:

A: No degradation in the performance of the EUT was observed.

7.6 Electrical Fast Transients/Burst at Power Port

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-4:2012
Performance Criterion:	B
Repetition Frequency:	5kHz
Burst Period:	300ms
Test Duration:	2 minute per level & polarity

7.6.1 Test Setup Diagram



7.6.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.6.3 Test Results:

Test Line	Level (kV)	Polarity	CDN/Clamp	Result / Observations
AC power port	1	+	CDN	A
AC power port	1	-	CDN	A

Results:

A: No degradation in the performance of the EUT was observed.

7.7 Electrical Fast Transients/Burst at Power Port

Test Requirement: EN 50130-4:2011 +A1:2014

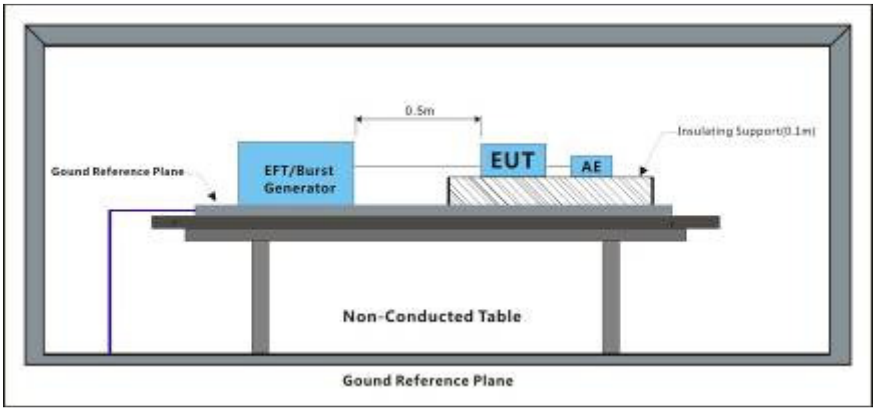
Test Method: EN 61000-4-4:2012

Repetition Frequency: 100kHz

Burst Period: 300ms

Test Duration: 1 minute per level & polarity

7.7.1 Test Setup Diagram



7.7.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.7.3 Test Results:

Test Line	Level (kV)	Polarity	CDN/Clamp	Result / Observations
AC power port	2	+	CDN	A
AC power port	2	-	CDN	A

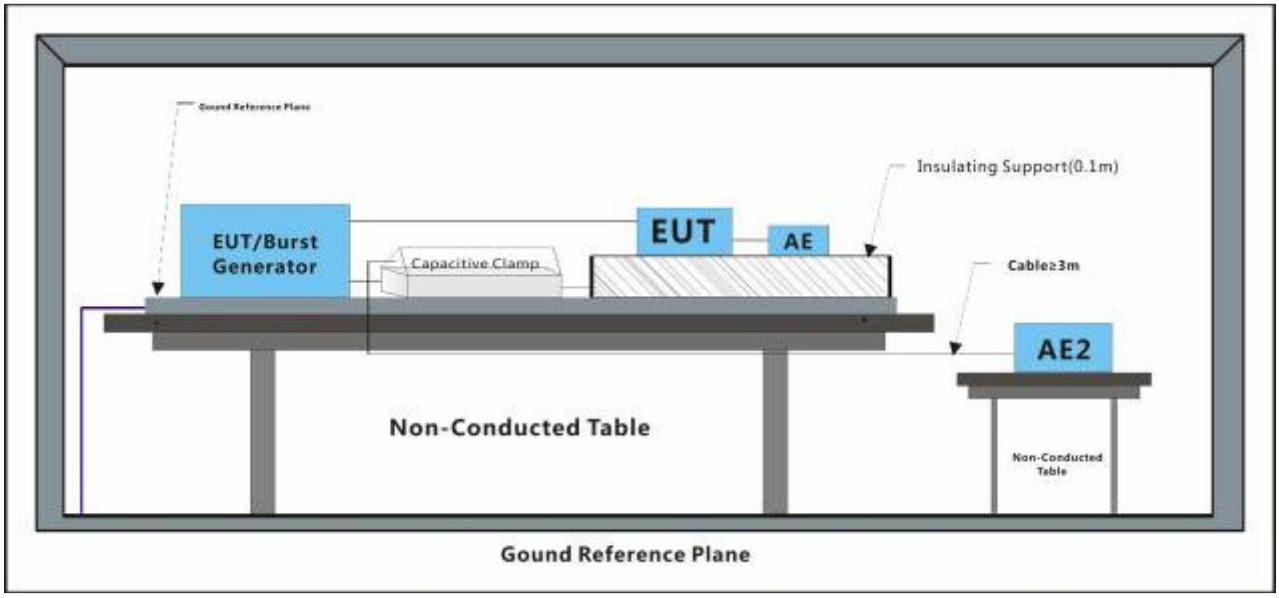
Results:

A: No degradation in the performance of the EUT was observed.

7.8 Electrical Fast Transients/Burst at Signal Port

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-4:2012
Performance Criterion:	B
Repetition Frequency:	5kHz
Burst Period:	300ms
Test Duration:	2 minute per level & polarity

7.8.1 Test Setup Diagram



7.8.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.8.3 Test Results:

Port	Level (kV)	Polarity	CDN/Clamp	Result / Observations
Signal port	0.5	+	Clamp	A
Signal port	0.5	-	Clamp	A

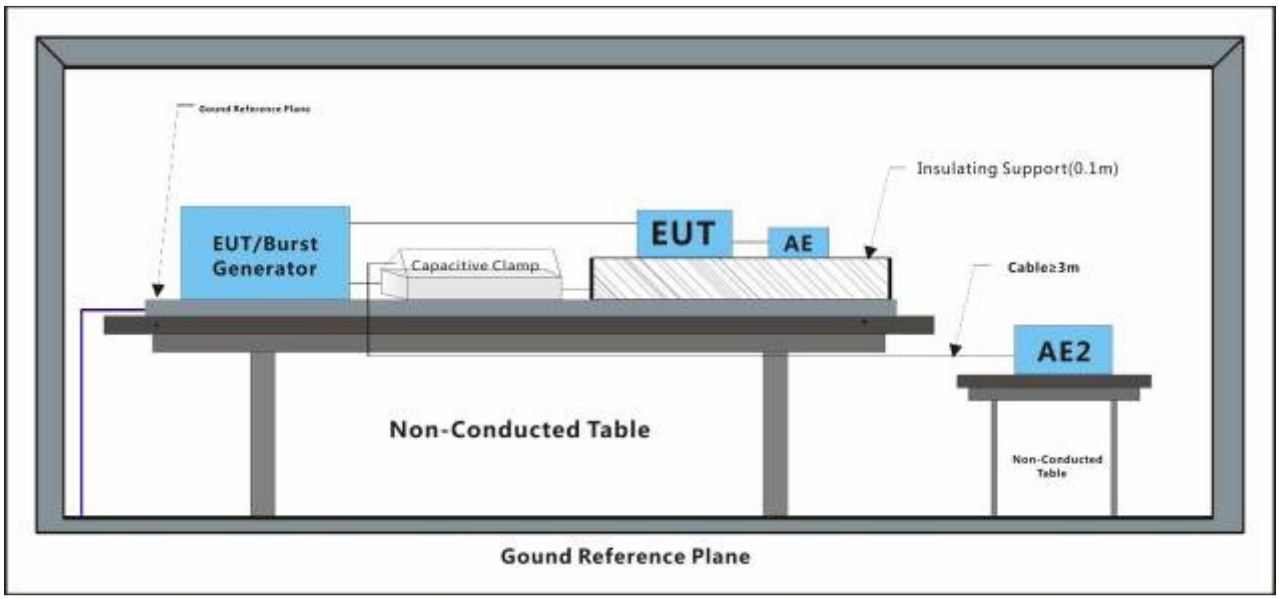
Results:

A: No degradation in the performance of the EUT was observed.

7.9 Electrical Fast Transients/Burst at Signal Port

Test Requirement: EN 50130-4:2011 +A1:2014
Test Method: EN 61000-4-4:2012
Repetition Frequency: 100kHz
Burst Period: 300ms
Test Duration: 1 minute per level & polarity

7.9.1 Test Setup Diagram



7.9.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .
b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.9.3 Test Results:

Port	Level (kV)	Polarity	CDN/Clamp	Result / Observations
Signal port	1	+	Clamp	A
Signal port	1	-	Clamp	A

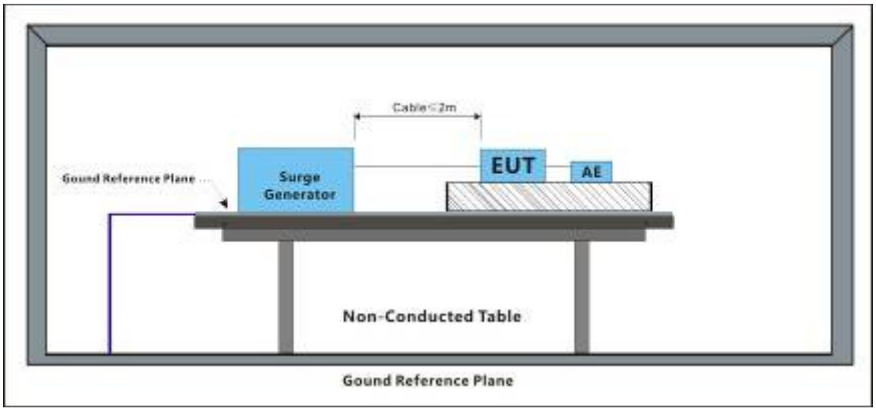
Results:

A: No degradation in the performance of the EUT was observed.

7.10 Surge at Power Port

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-5:2014
Performance Criterion:	B
Interval:	60s between each surge
No. of surges:	5 positive, 5 negative at 0°, 90°, 180°, 270°.

7.10.1 Test Setup Diagram



7.10.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.10.3 Test Results:

Test Line	Level (kV)	Polarity	Phase (deg)	Result / Observations
L-N	1	+	0°	A
L-N	1	-	0°	A
L-N	1	+	90°	A
L-N	1	-	90°	A
L-N	1	+	180°	A
L-N	1	-	180°	A
L-N	1	+	270°	A
L-N	1	-	270°	A

Results:

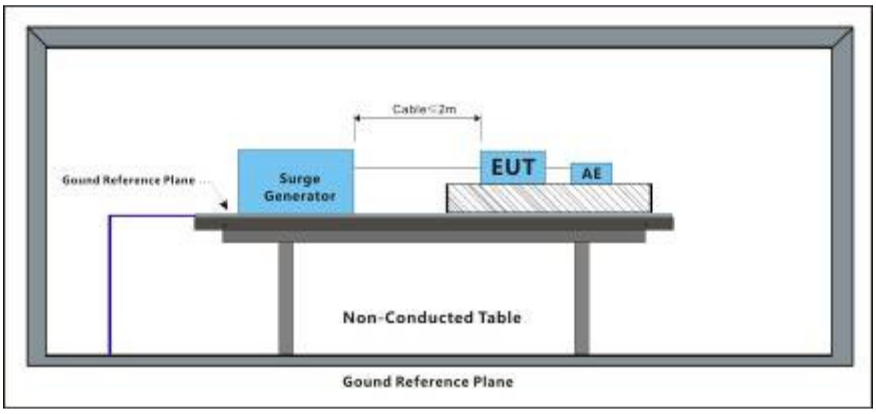
A: No degradation in the performance of the EUT was observed.

7.11 Surge at Power Port

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 61000-4-5:2014

7.11.1 Test Setup Diagram



7.11.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.11.3 Test Results:

Test Line	Level (kV)	Polarity	Phase (deg)	Result / Observations
L-N	0.5,1	+	0°	A
L-N	0.5,1	-	0°	A
L-N	0.5,1	+	90°	A
L-N	0.5,1	-	90°	A
L-N	0.5,1	+	180°	A
L-N	0.5,1	-	180°	A
L-N	0.5,1	+	270°	A
L-N	0.5,1	-	270°	A

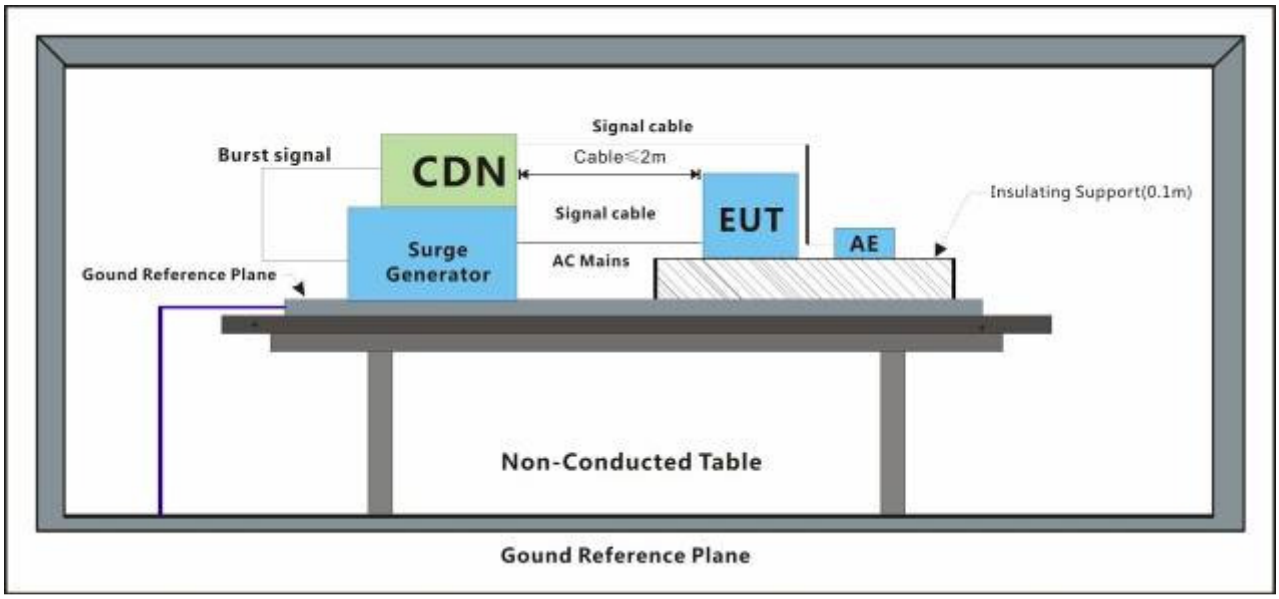
Results:

A: No degradation in the performance of the EUT was observed.

7.12 Surge at Signal Port

Test Requirement: EN 55024:2010 +A1:2015
Test Method: EN 61000-4-5:2014
Performance Criterion: B
Interval: 60s between each surge

7.12.1 Test Setup Diagram



7.12.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .
b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.12.3 Test Results:

Port	Line	Level (kV)	Polarity	Result / Observations
Signal port	Line-Ground	1	+	A
Signal port	Line-Ground	1	-	A

Results:

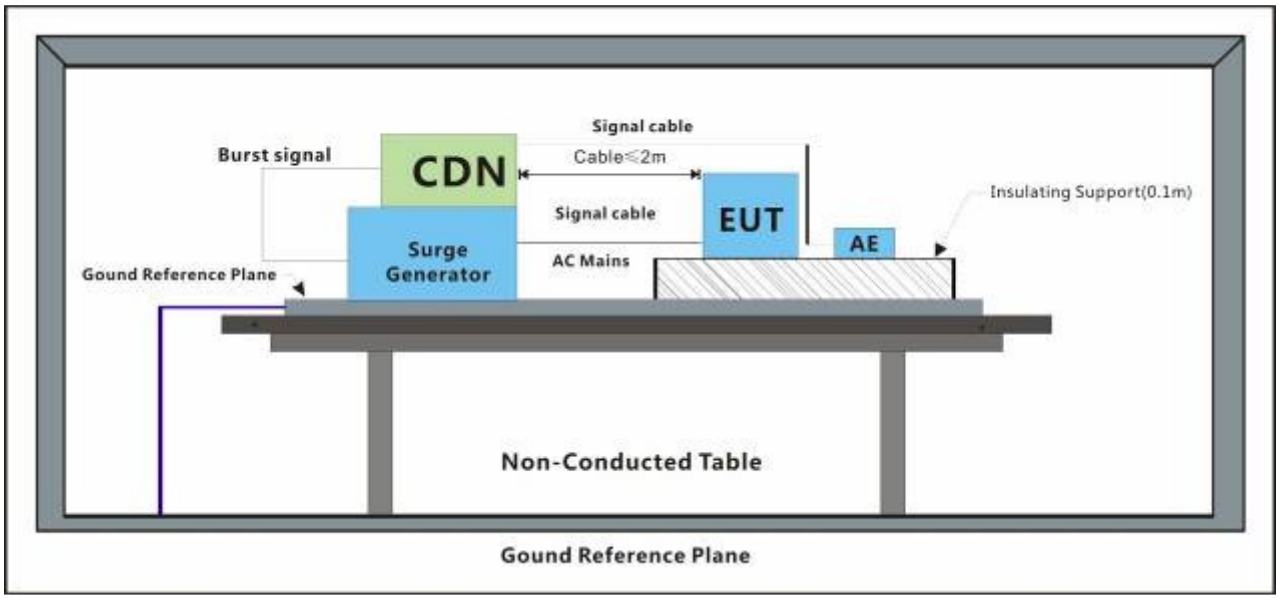
A: No degradation in the performance of the EUT was observed.

7.13 Surge at Signal Port

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 61000-4-5:2014

7.13.1 Test Setup Diagram



7.13.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.13.3 Test Results:

Port	Line	Level (kV)	Polarity	Result / Observations
Signal port	Line-Ground	0.5	+	A
Signal port	Line-Ground	0.5	-	A
Signal port	Line-Ground	1	+	A
Signal port	Line-Ground	1	-	A

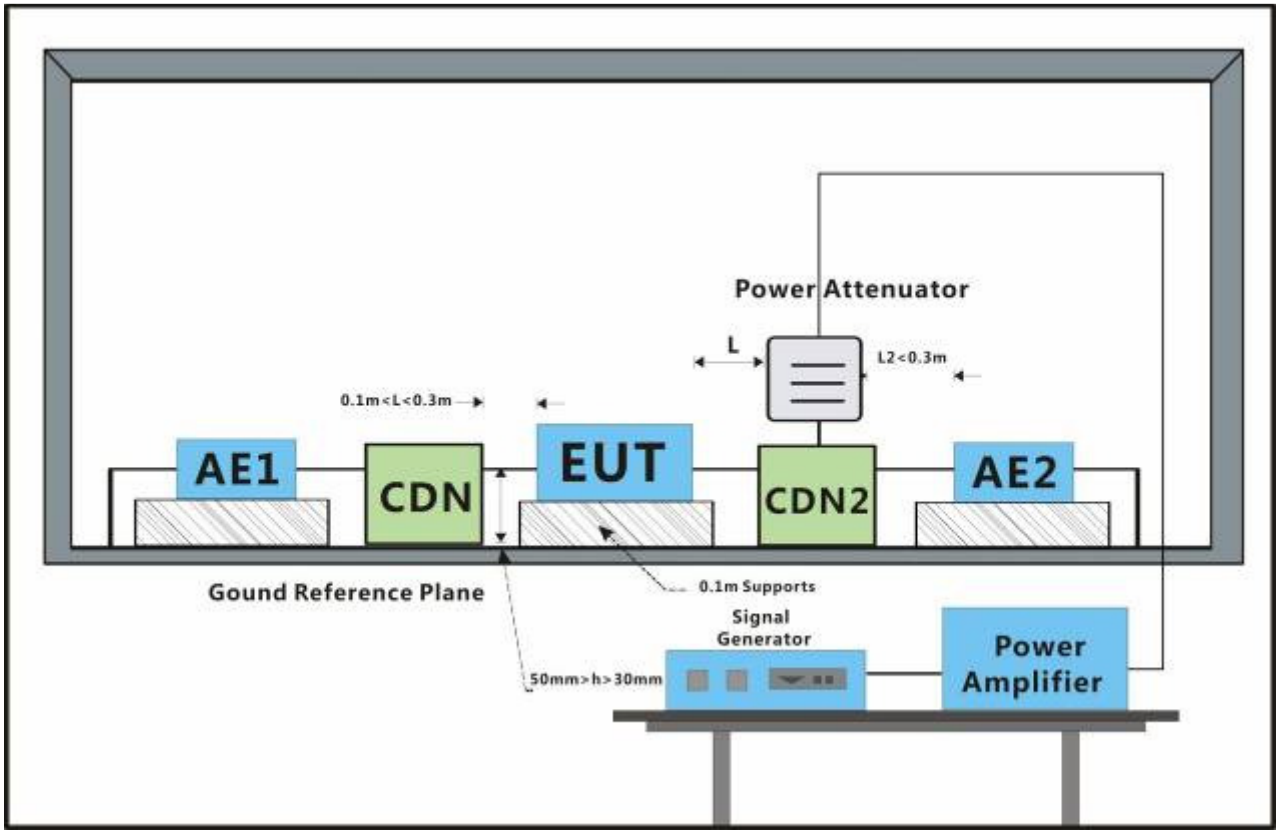
Results:

A: No degradation in the performance of the EUT was observed.

7.14 Conducted Immunity at Power Port (150kHz-80MHz)

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-6:2014
Performance Criterion:	A
Frequency Range:	0.15MHz to 80MHz
Modulation:	80%, 1kHz Amplitude Modulation
Step Size	1%

7.14.1 Test Setup Diagram



7.14.2 E.U.T. Operation

Operating Environment:

Temperature: 21 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.14.3 Test Results:

Cable port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
AC power port	3	CDN	3s	A

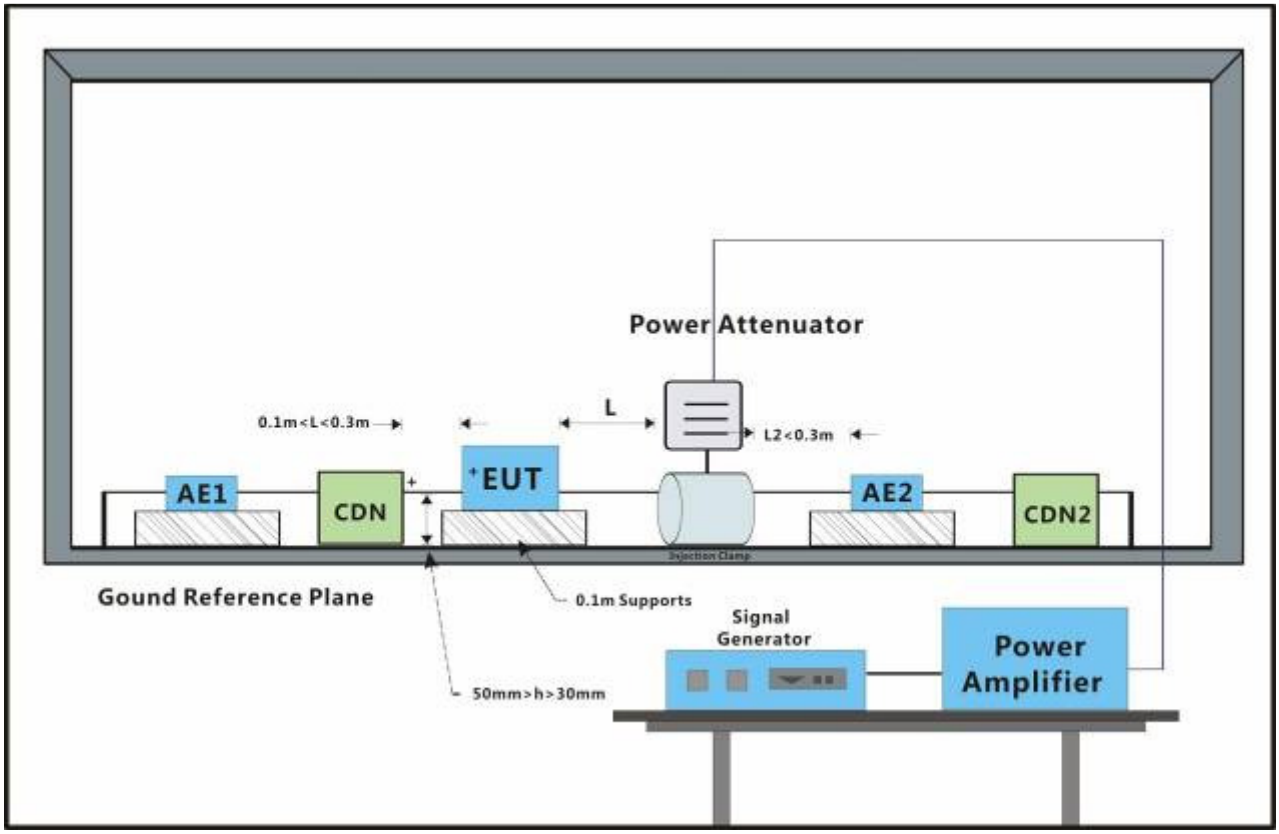
Results:

A: No degradation in the performance of the EUT was observed.

7.15 Conducted Immunity at Signal Port (150kHz-80MHz)

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-6:2014
Performance Criterion:	A
Frequency Range:	0.15MHz to 80MHz
Modulation:	80%, 1kHz Amplitude Modulation
Step Size	1%

7.15.1 Test Setup Diagram



7.15.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.15.3 Test Results:

Port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
Signal port	3	Coupling	3s	A

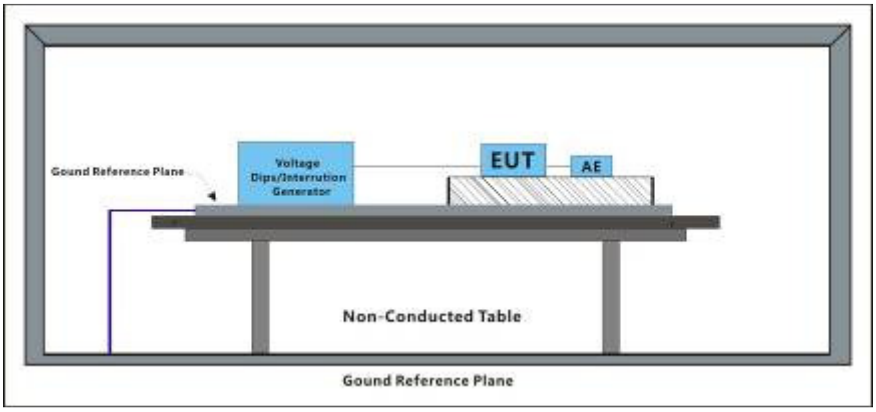
Results:

A: No degradation in the performance of the EUT was observed.

7.16 Voltage Dips and Interruptions

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-11:2004
Performance Criterion:	0% of UT (Supply Voltage) for 0.5 Periods:B, 0% of UT for 250 Periods:C, 70 % of UT for 25 Periods:C
No. of Dips / Interruptions:	3 per Level
Time between dropout	10s

7.16.1 Test Setup Diagram



7.16.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.16.3 Test Results:

Level % UT	Phase (deg)	Duration	No. of Dips / Interruptions	Result / Observations
0	0°	0.5 Cycles	3	A
0	180°	0.5 Cycles	3	A
0	0°	250 Cycles	3	B
0	180°	250 Cycles	3	B
70	0°	25 Cycles	3	A
70	180°	25 Cycles	3	A

Results:

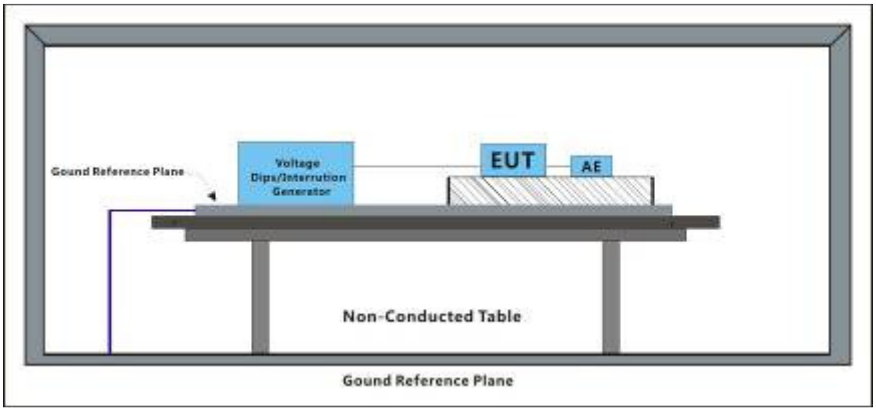
A: No degradation in the performance of the EUT was observed.

B: During test, EUT stop work, After test ,the EUT restarted automatically

7.17 Voltage Dips and Interruptions

Test Requirement:	EN 50130-4:2011 +A1:2014
Test Method:	EN 61000-4-11:2004
Performance Criterion:	0% of UT (Supply Voltage) for 250 Periods, 40% of UT for 10 Periods, 70% of UT for 25 Periods, 80% of UT for 250 Periods,
No. of Dips / Interruptions:	3 per Level
Time between dropout	10s

7.17.1 Test Setup Diagram



7.17.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.17.3 Test Results:

Level % UT	Phase (deg)	Duration	No. of Dips / Interruptions	Result / Observations
80	0°	250 Cycles	3	A
80	180°	250 Cycles	3	A
70	0°	25 Cycles	3	A
70	180°	25 Cycles	3	A
40	0°	10 Cycles	3	A
40	180°	10 Cycles	3	A
0	0°	250 Cycles	3	B
0	180°	250 Cycles	3	B

Results:

A: No degradation in the performance of the EUT was observed.

B: During test, EUT stop work, After test ,the EUT restarted automatically

7.18 Mains Supply Voltage Variations-Conditioning

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 50130-4:2011+A1:2014

7.18.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.18.2 Test Results:

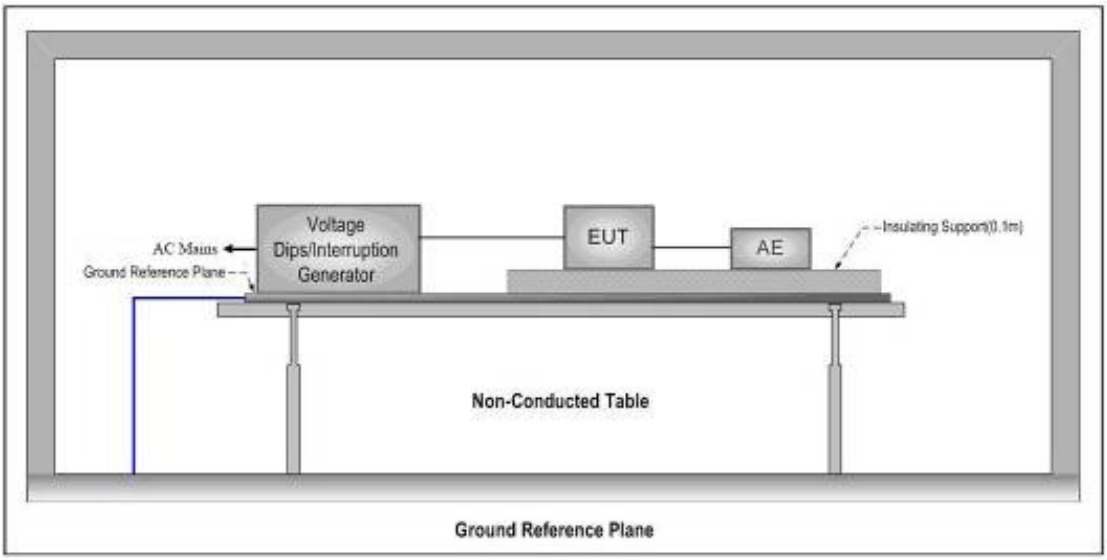
Test phenomenon description for the EUT:

1. The EUT working normal, before the conditioning.

2. Monitor the EUT during the conditioning period and detected no any changes in states, during the conditioning.

3. No degradation in the performance of the EUT was observed, after the conditioning.

Test Setup:

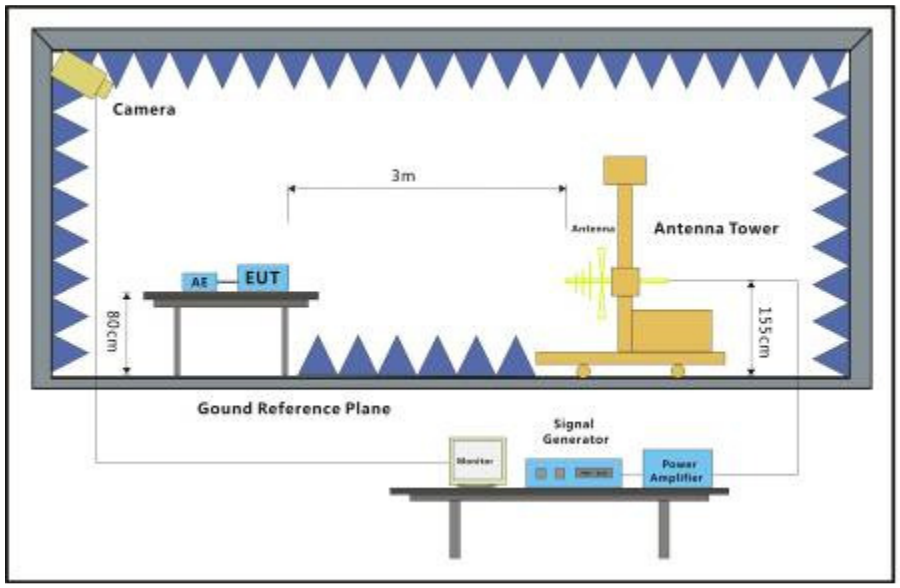


7.19 Radiated Immunity(80MHz-2.7GHz)

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 61000-4-3:2006 +A1:2008+A2:2010

7.19.1 Test Setup Diagram



7.19.2 E.U.T. Operation

Operating Environment:

Temperature: 20 °C Humidity: 50 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.19.3 Test Results:

Frequency	Level (V/m)	EUT Face	Dwell time	Result / Observations
80MHz-2.7GHz	10	Front	2s	A
80MHz-2.7GHz	10	Back	2s	A
80MHz-2.7GHz	10	Left	2s	A
80MHz-2.7GHz	10	Right	2s	A
80MHz-2.7GHz	10	Top	2s	A
80MHz-2.7GHz	10	Underside	2s	A

Results:

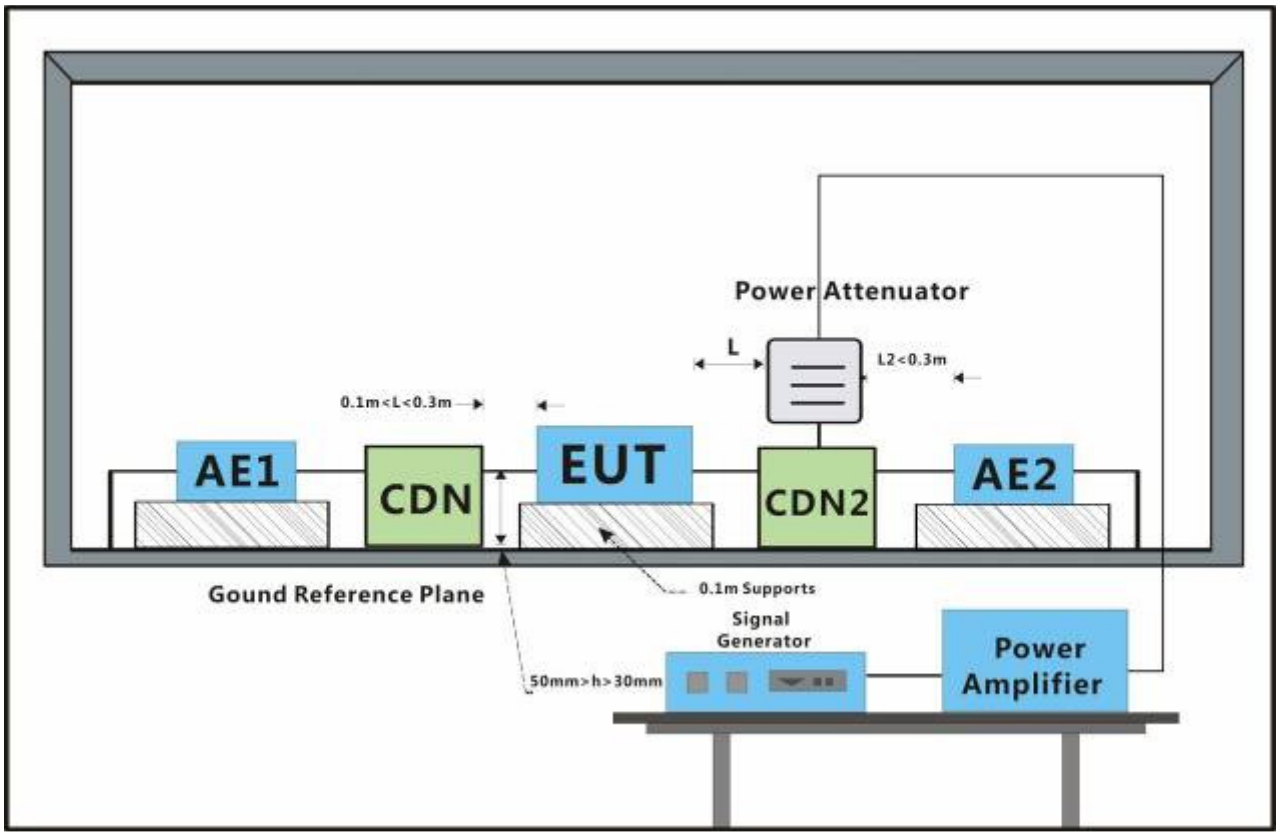
A: No degradation in the performance of the EUT was observed.

7.20 Conducted Immunity at Power Port (150kHz-100MHz)

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 61000-4-6:2014

7.20.1 Test Setup Diagram



7.20.2 E.U.T. Operation

Operating Environment:

Temperature: 21 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.20.3 Test Results:

Cable port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
AC power port	10	CDN	3s	A

Results:

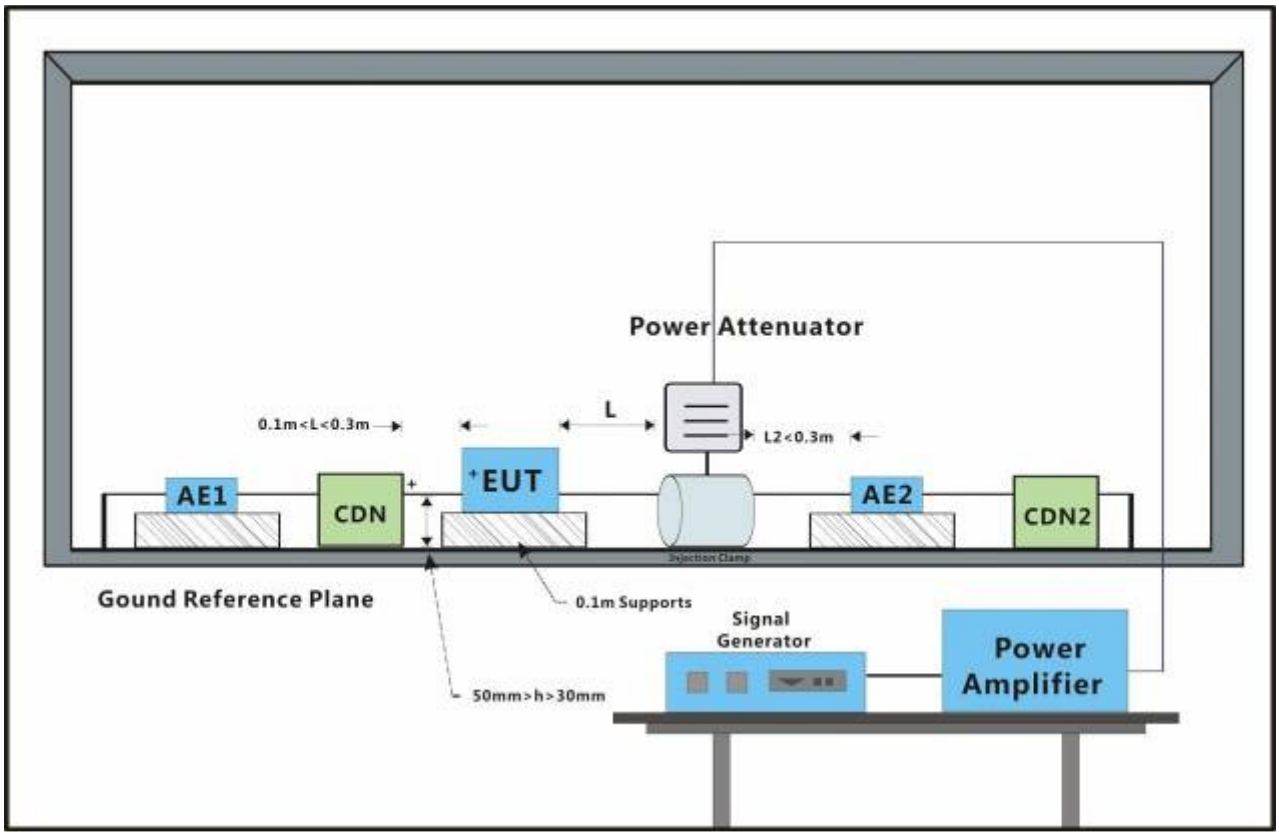
A: No degradation in the performance of the EUT was observed.

7.21 Conducted Immunity at Signal Port (150kHz-100MHz)

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 61000-4-6:2014

7.21.1 Test Setup Diagram



7.21.2 E.U.T. Operation

Operating Environment:

Temperature: 21 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:DC12V monitoring : keep EUT monitoring under DC12V supply continual .

b: PoE monitoring : keep EUT monitoring under PoE supply conitnual .

7.21.3 Test Results:

Port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
Signal port	10	Coupling	3s	A

Results:

A: No degradation in the performance of the EUT was observed.

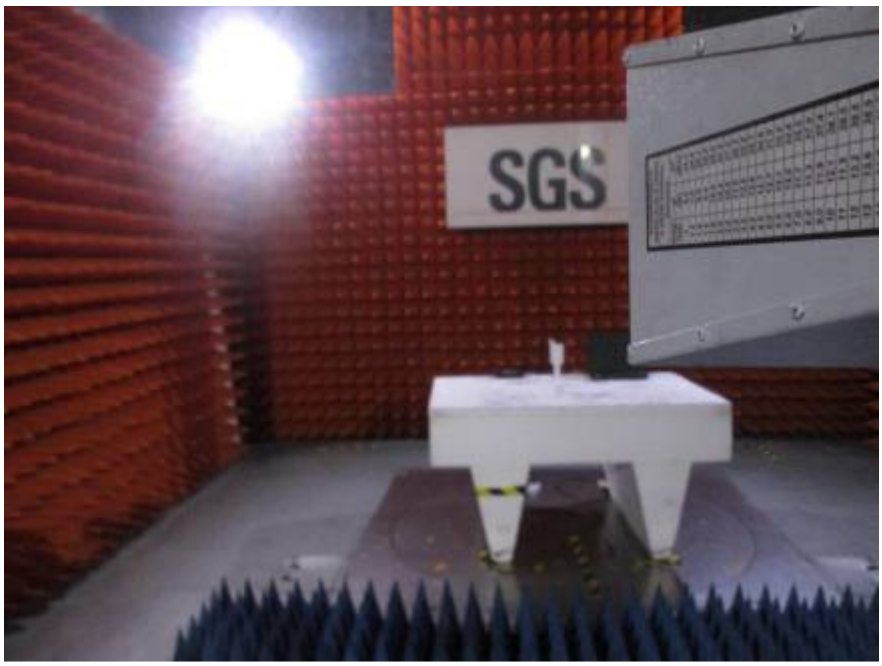
8 Photographs

8.1 Conducted Emissions at Mains Terminals (150kHz-30MHz) Test Setup

8.2 Asymmetric Mode Conducted Emissions (150kHz-30MHz) Test Setup

8.3 Radiated Emissions (30MHz-1GHz) Test Setup

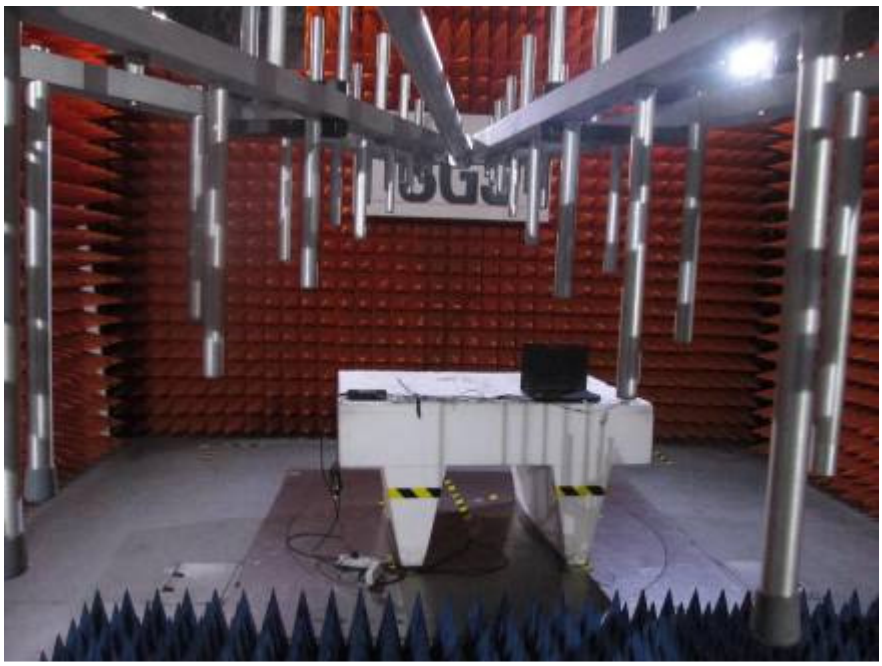
8.4 Radiated Emissions (above 1GHz) Test Setup



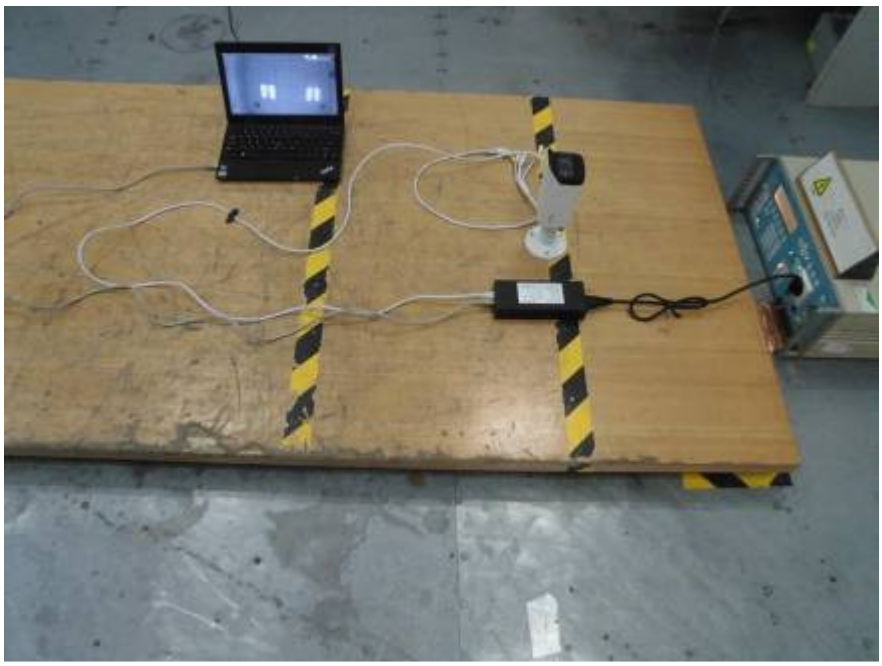
8.5 Voltage Fluctuations and Flicker Test Setup

8.6 Electrostatic Discharge Test Setup

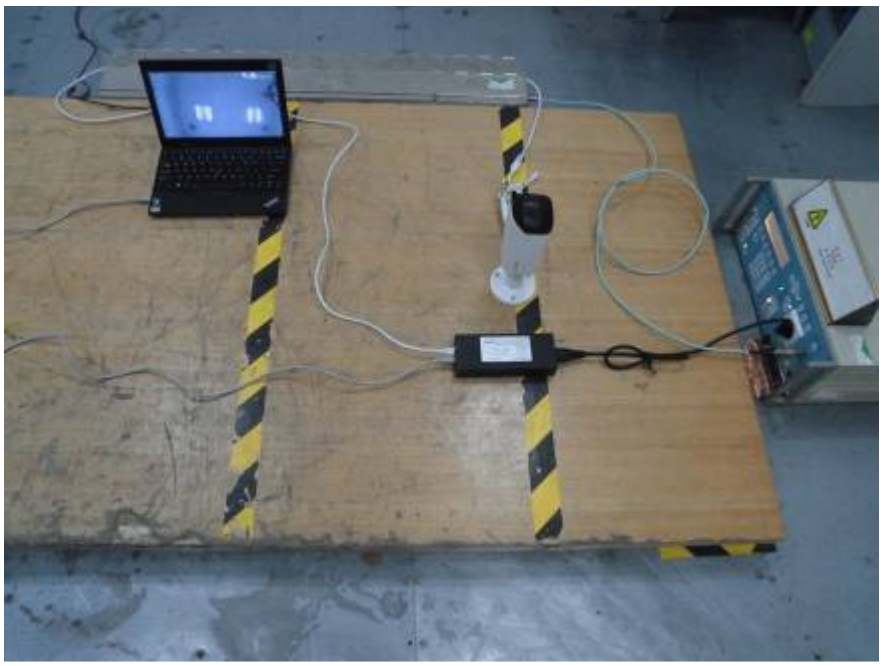
8.7 Radiated Immunity (80MHz-1GHz) Test Setup



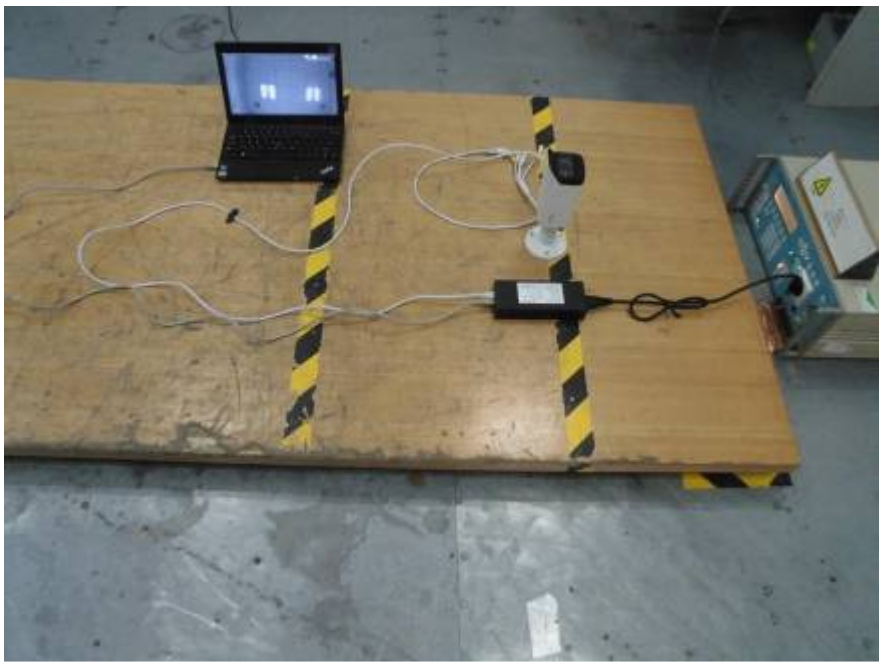
8.8 Electrical Fast Transients/Burst at Power Port Test Setup



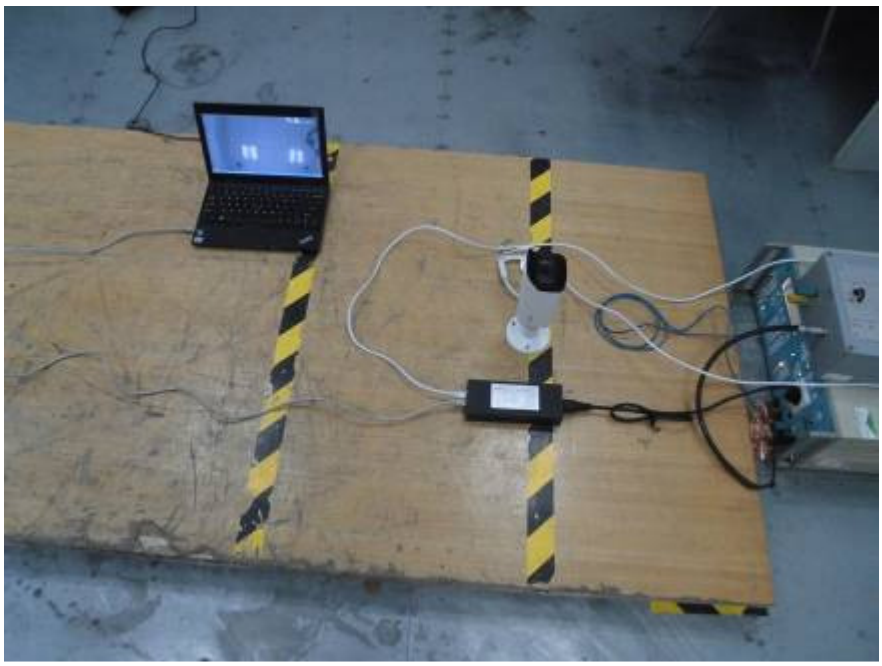
8.9 Electrical Fast Transients/Burst at Signal Port Test Setup



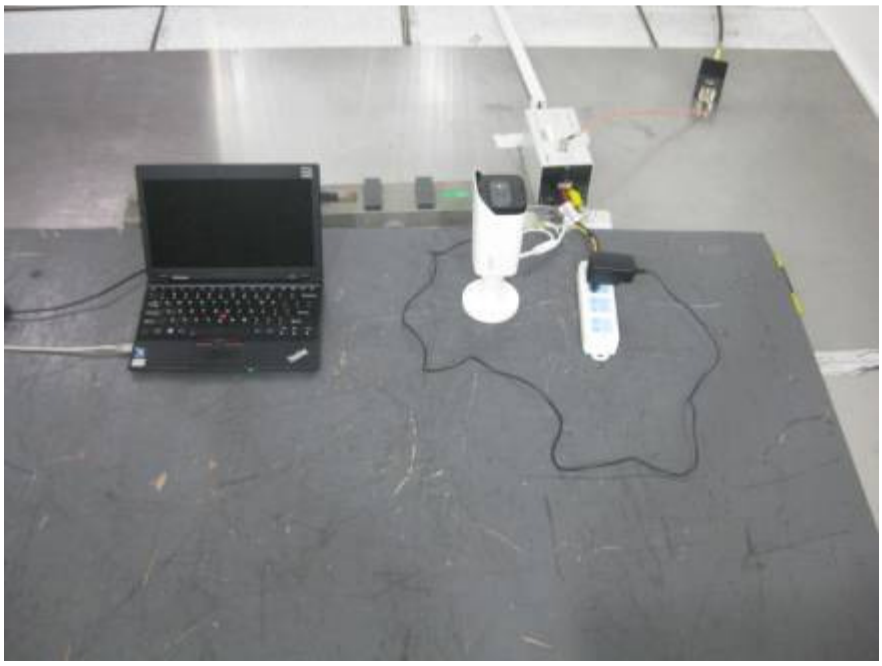
8.10 Surge at Power Port Test Setup

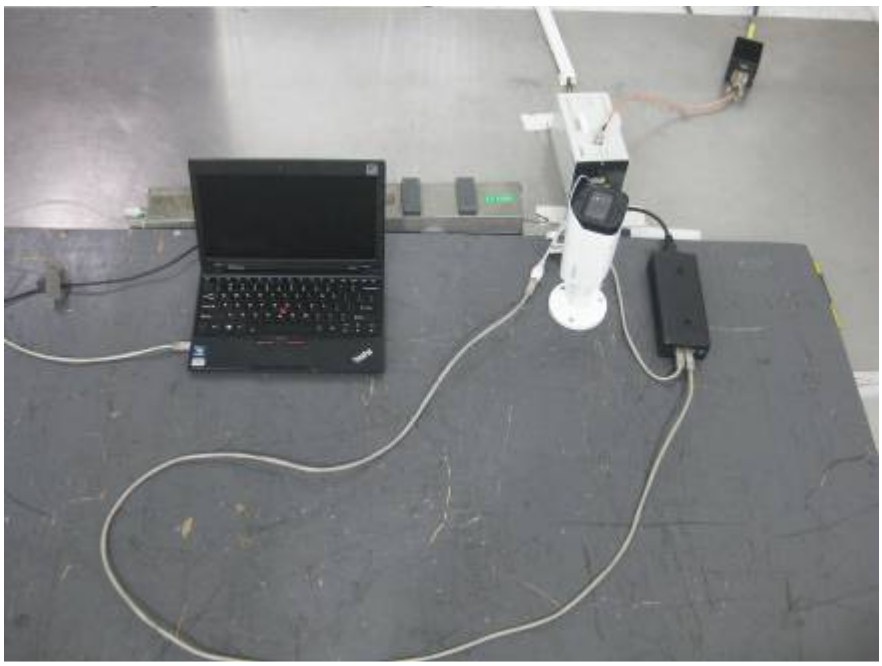


8.11 Surge at Signal Port Test Setup

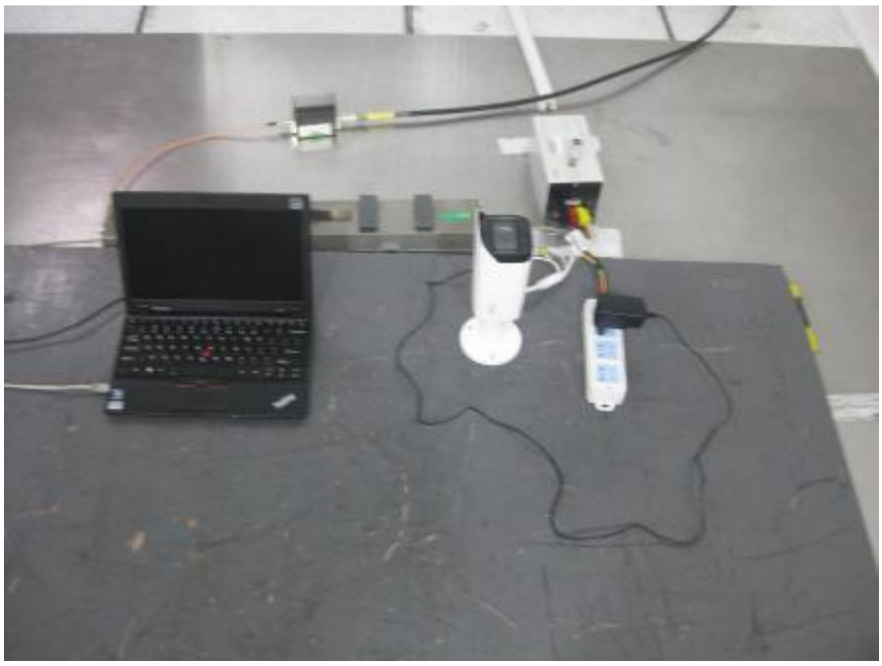


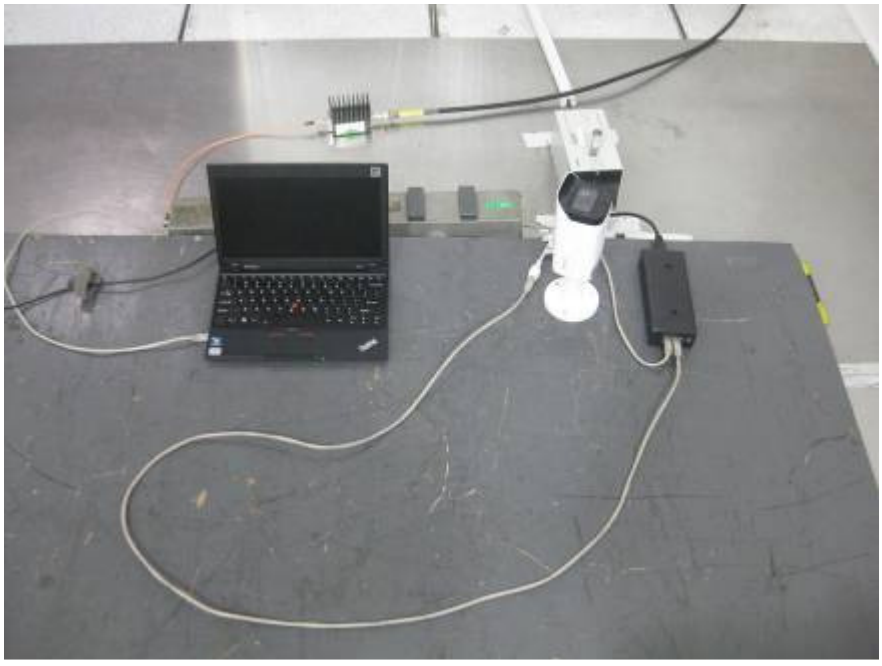
8.12 Conducted Immunity at Power Port (150kHz-80MHz) Test Setup



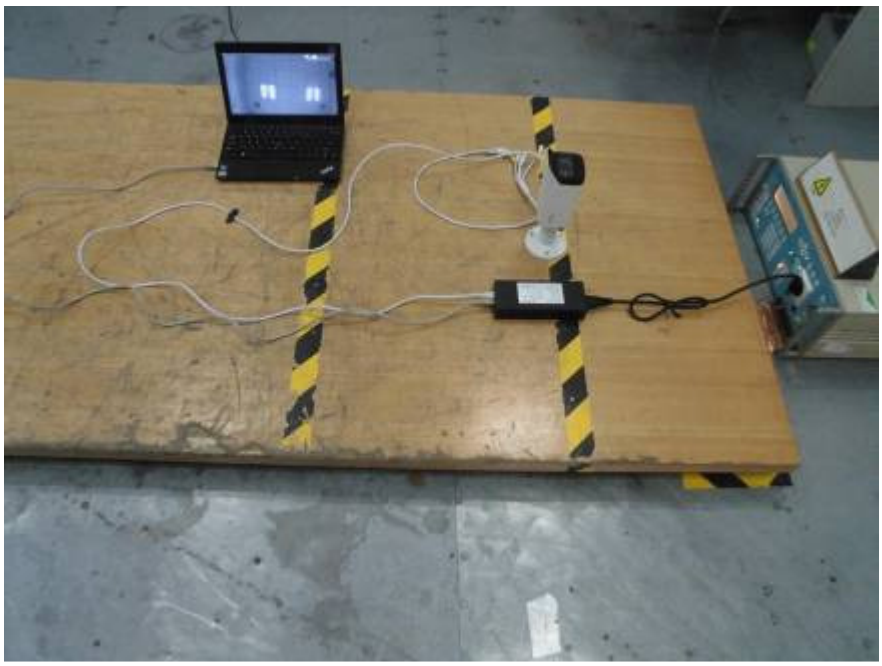


8.13 Conducted Immunity at Signal Port (150kHz-80MHz) Test Setup

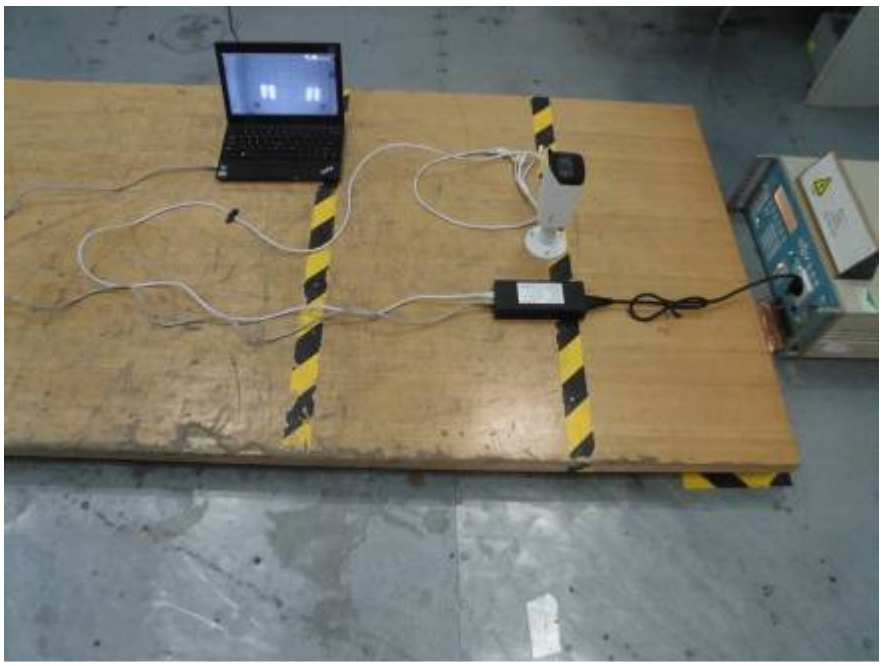




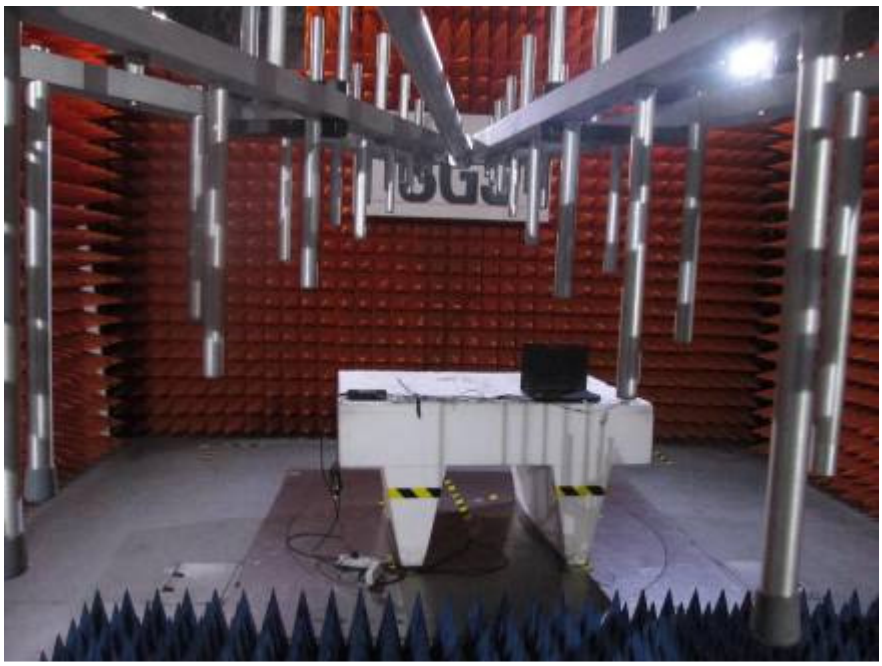
8.14 Voltage Dips and Interruptions Test Setup



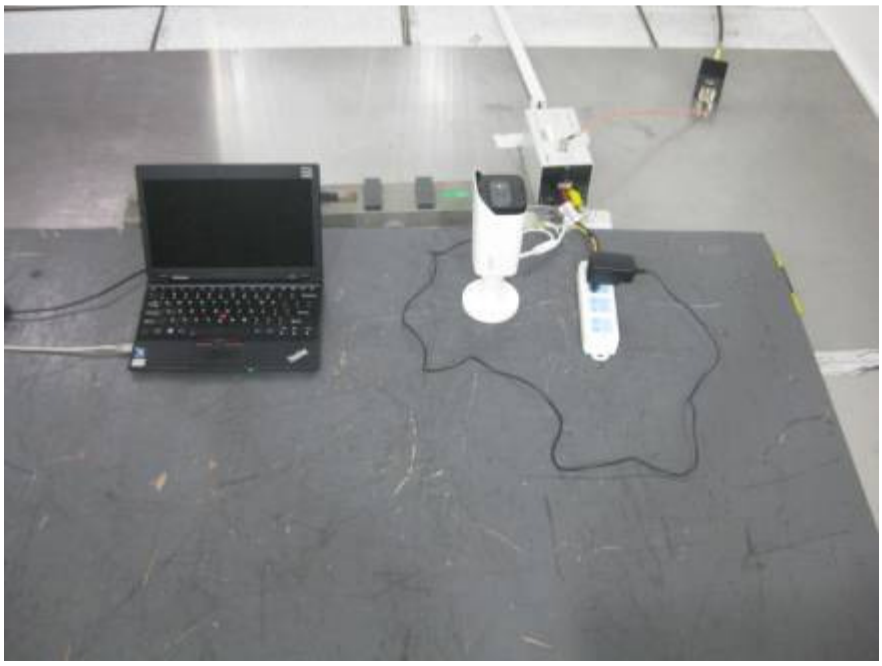
8.15 Mains Supply Voltage Variations-Conditioning Test Setup

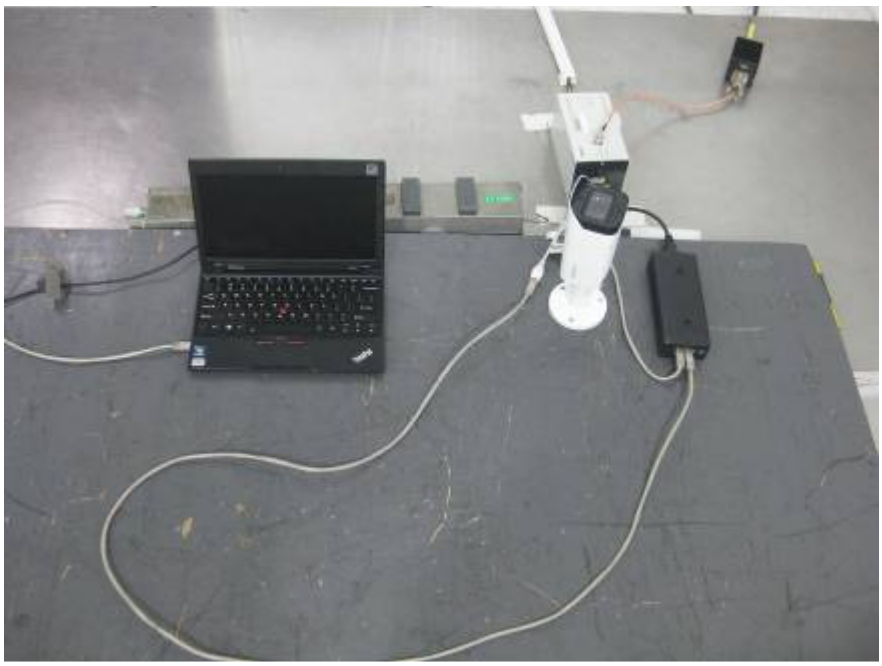


8.16 Radiated Immunity(80MHz-2.7GHz) Test Setup

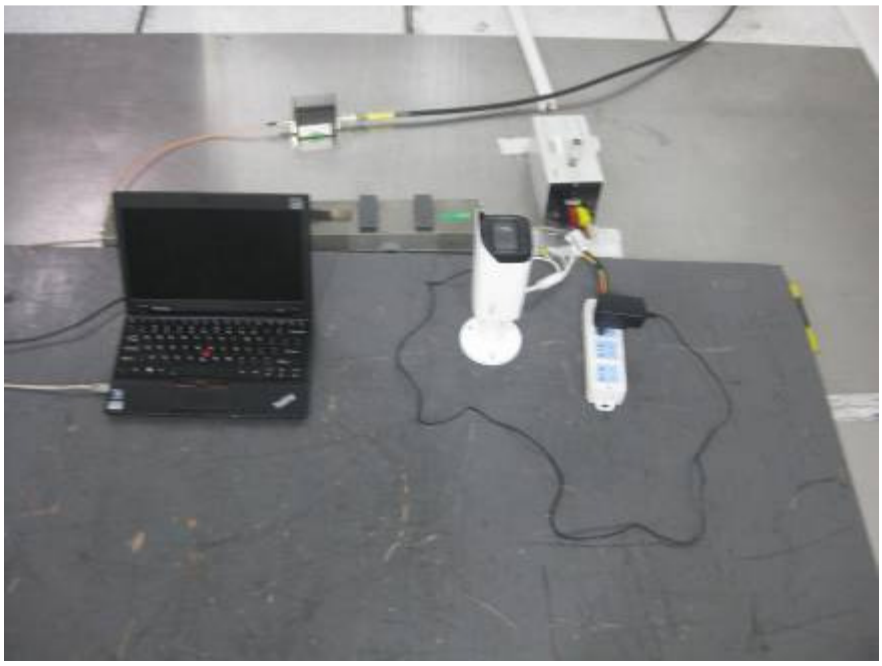


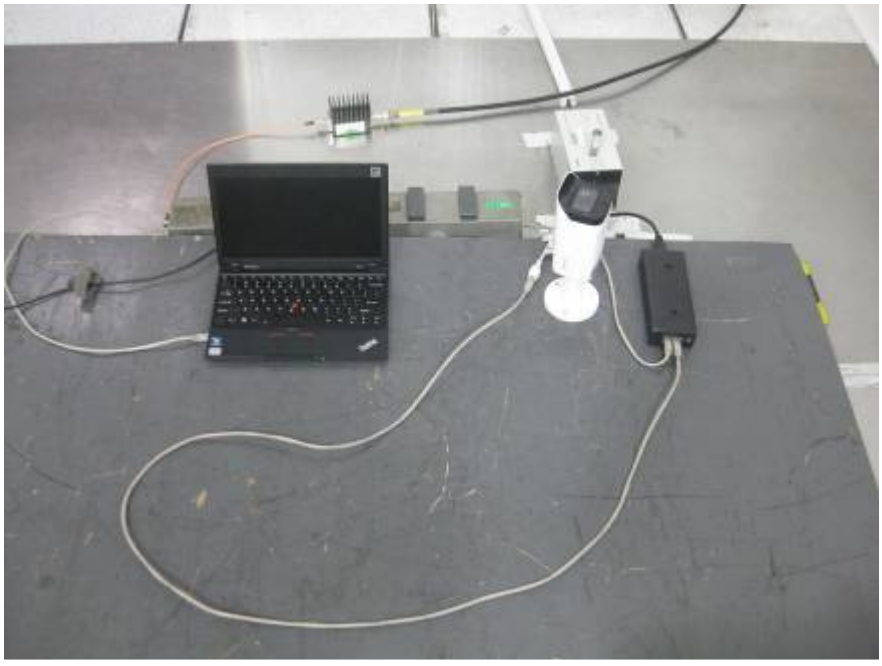
8.17 Conducted Immunity at Power Port (150kHz-100MHz) Test Setup



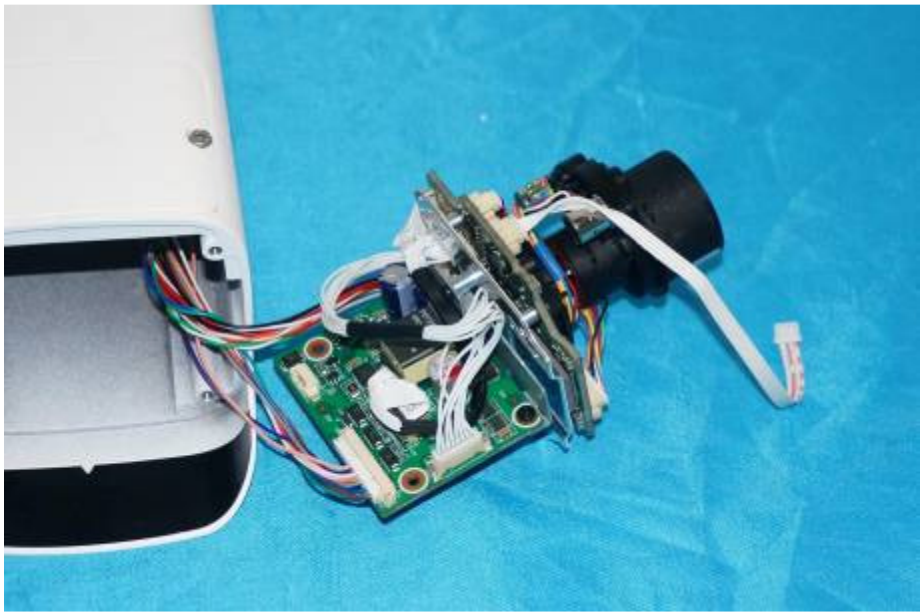


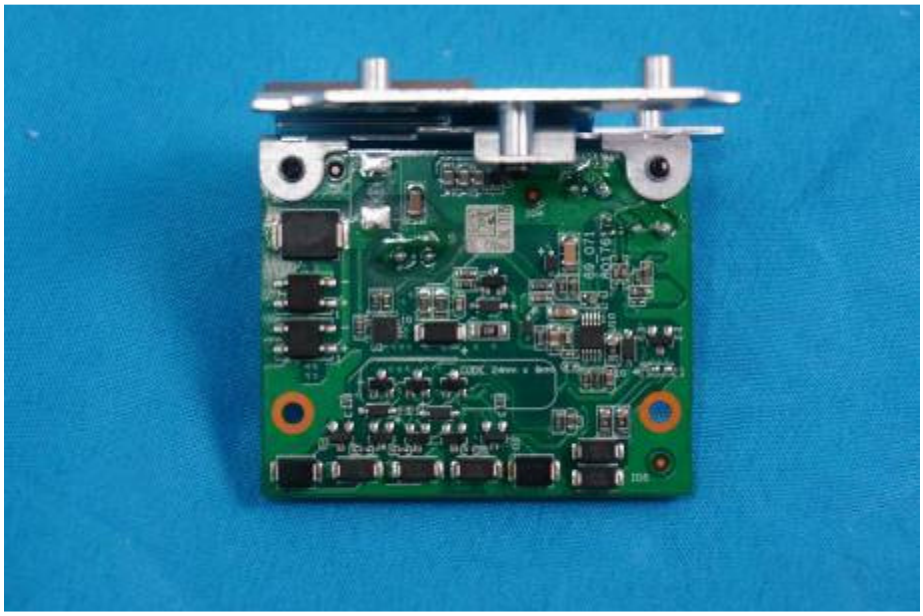
8.18 Conducted Immunity at Signal Port (150kHz-100MHz) Test Setup

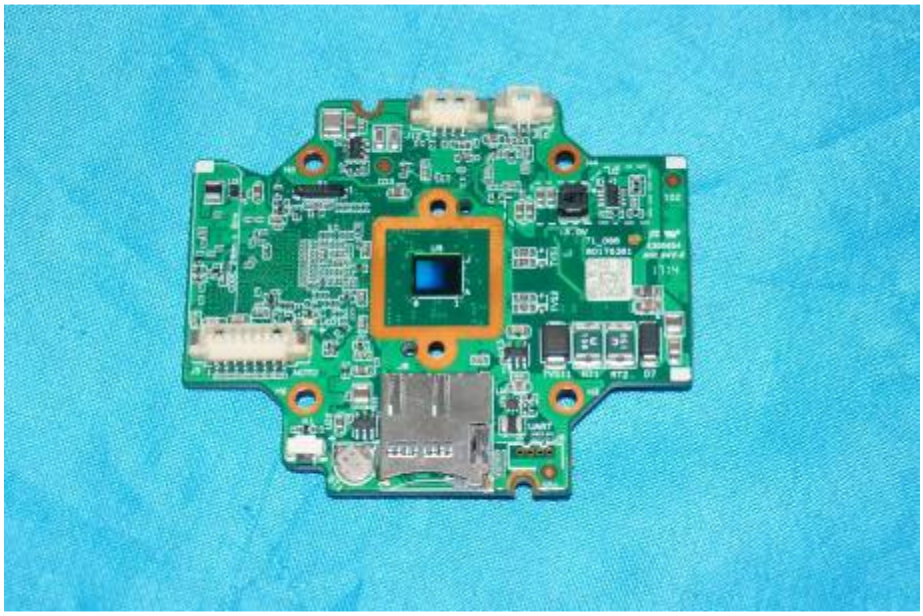




8.19 EUT Constructional Details







--End of the Report--